

### FEATURES

Single 18-bit DAC,  $\pm 0.5$  LSB INL  
 7.5 nV/ $\sqrt{\text{Hz}}$  noise spectral density  
 0.05 LSB long-term linearity stability  
 $< 0.05$  ppm/ $^{\circ}\text{C}$  temperature drift  
 1  $\mu\text{s}$  settling time  
 1.4 nV-sec glitch impulse  
 Operating temperature range:  $-40^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$   
 20-lead TSSOP package  
 Wide power supply range of up to  $\pm 16.5$  V  
 35 MHz Schmitt triggered digital interface  
 1.8 V compatible digital interface

### APPLICATIONS

Medical instrumentation  
 Test and measurement  
 Industrial control  
 Scientific and aerospace instrumentation  
 Data acquisition systems  
 Digital gain and offset adjustment  
 Power supply control

### GENERAL DESCRIPTION

The AD5781<sup>1</sup> is a single 18-bit, unbuffered voltage output DAC that operates from a bipolar supply of up to 33 V. The AD5781 accepts a positive reference input range of 5 V to  $V_{\text{DD}} - 2.5$  V and a negative reference input range of  $V_{\text{SS}} + 2.5$  V to 0 V. The AD5781 offers a relative accuracy specification of  $\pm 0.5$  LSB maximum, and operation is guaranteed monotonic with a  $\pm 0.5$  LSB DNL maximum specification.

The part uses a versatile 3-wire serial interface that operates at clock rates of up to 35 MHz and is compatible with standard SPI, QSPI™, MICROWIRE™, and DSP interface standards. The part incorporates a power-on reset circuit that ensures that the DAC output powers up to 0 V and in a known output impedance state and remains in this state until a valid write to the device takes place. The part provides an output clamp feature that places the output in a defined load state.

<sup>1</sup> Protected by U.S. Patent No 7884747, and other patents are pending.

#### Rev. C

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### FUNCTIONAL BLOCK DIAGRAM

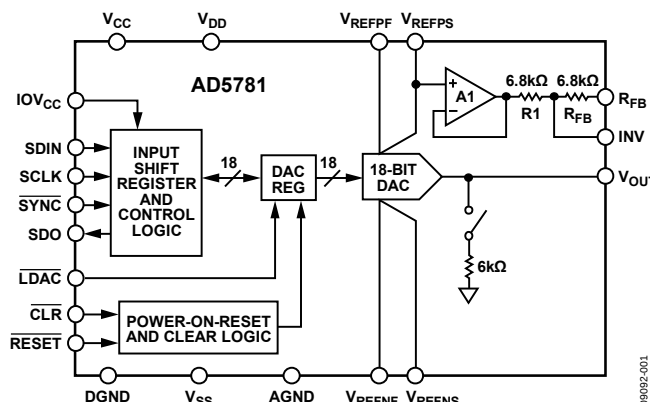


Figure 1.

Table 1. Complementary Devices

| Part No.  | Description                                                                      |
|-----------|----------------------------------------------------------------------------------|
| AD8675    | Ultraprecision, 36 V, 2.8 nV/ $\sqrt{\text{Hz}}$ rail-to-rail output op amp      |
| AD8676    | Ultraprecision, 36 V, 2.8 nV/ $\sqrt{\text{Hz}}$ dual rail-to-rail output op amp |
| ADA4898-1 | High voltage, low noise, low distortion, unity gain stable, high speed op amp    |

Table 2. Related Devices

| Part No.        | Description                    |
|-----------------|--------------------------------|
| AD5791          | 20-bit, 1 ppm accurate DAC     |
| AD5541A/AD5542A | 16-bit, 1 LSB accurate 5 V DAC |

### PRODUCT HIGHLIGHTS

1. True 18-Bit Accuracy.
2. Wide Power Supply Range of Up to  $\pm 16.5$  V.
3.  $-40^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$  Operating Temperature Range.
4. Low 7.5 nV/ $\sqrt{\text{Hz}}$  Noise.
5. Low 0.05 ppm/ $^{\circ}\text{C}$  Temperature Drift.

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## REVISION HISTORY

### 11/11—Rev. B to Rev. C

|                                                 |    |
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### 9/11—Rev. A to Rev. B

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### 8/11—Rev. 0 to Rev. A

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| Added New Figure 44, Figure 45, and Figure 46, Renumbered<br>Sequentially ..... | 16 |

### 7/10—Revision 0: Initial Version

## SPECIFICATIONS

$V_{DD} = +12.5\text{ V to }+16.5\text{ V}$ ,  $V_{SS} = -16.5\text{ V to }-12.5\text{ V}$ ,  $V_{REFP} = +10\text{ V}$ ,  $V_{REFN} = -10\text{ V}$ ,  $V_{CC} = +2.7\text{ V to }+5.5\text{ V}$ ,  $IOV_{CC} = +1.71\text{ V to }+5.5\text{ V}$ ,  $R_L = \text{unloaded}$ ,  $C_L = \text{unloaded}$ ,  $T_{MIN}$  to  $T_{MAX}$ , unless otherwise noted.

Table 3.

| Parameter                                             | A, B Version <sup>1</sup> |        |                   | Unit       | Test Conditions/Comments                                                                             |
|-------------------------------------------------------|---------------------------|--------|-------------------|------------|------------------------------------------------------------------------------------------------------|
|                                                       | Min                       | Typ    | Max               |            |                                                                                                      |
| STATIC PERFORMANCE <sup>2</sup>                       |                           |        |                   |            |                                                                                                      |
| Resolution                                            | 18                        |        |                   | Bits       |                                                                                                      |
| Integral Nonlinearity Error (Relative Accuracy)       | −0.5                      | ±0.25  | +0.5              | LSB        | B version, V <sub>REFP</sub> = +10 V, V <sub>REFN</sub> = −10 V                                      |
|                                                       | −0.5                      | ±0.25  | +0.5              | LSB        | B version, V <sub>REFP</sub> = +10 V, V <sub>REFN</sub> = 0 V <sup>3</sup>                           |
|                                                       | −1                        | ±0.5   | +1                | LSB        | B version, V <sub>REFP</sub> = +5 V, V <sub>REFN</sub> = 0 V <sup>3</sup>                            |
|                                                       | −4                        | ±2     | +4                | LSB        | A version <sup>4</sup>                                                                               |
| Differential Nonlinearity Error                       | −0.5                      | ±0.25  | +0.5              | LSB        | V <sub>REFP</sub> = +10 V, V <sub>REFN</sub> = −10 V                                                 |
|                                                       | −0.5                      | ±0.25  | +0.5              | LSB        | V <sub>REFP</sub> = +10 V, V <sub>REFN</sub> = 0 V <sup>3</sup>                                      |
|                                                       | −1                        | ±0.5   | +1                | LSB        | V <sub>REFP</sub> = +5 V, V <sub>REFN</sub> = 0 V <sup>3</sup>                                       |
| Linearity Error Long-Term Stability <sup>5</sup>      |                           | 0.04   |                   | LSB        | After 500 hours at T <sub>A</sub> = 125°C                                                            |
|                                                       |                           | 0.05   |                   | LSB        | After 1000 hours at T <sub>A</sub> = 125°C                                                           |
|                                                       |                           | 0.03   |                   | LSB        | After 1000 hours t T <sub>A</sub> = 100°C                                                            |
| Full-Scale Error                                      | −1.75                     | ±0.25  | +1.75             | LSB        | V <sub>REFP</sub> = +10 V, V <sub>REFN</sub> = −10 V <sup>3</sup>                                    |
|                                                       | −2.75                     | ±0.062 | +2.75             | LSB        | V <sub>REFP</sub> = +10 V, V <sub>REFN</sub> = 0 V <sup>3</sup>                                      |
|                                                       | −5.25                     | ±0.2   | +5.25             | LSB        | V <sub>REFP</sub> = +5 V, V <sub>REFN</sub> = 0 V <sup>3</sup>                                       |
|                                                       | −1                        | ±0.25  | +1                | LSB        | V <sub>REFP</sub> = +10 V, V <sub>REFN</sub> = −10 V <sup>3</sup> ,<br>T <sub>A</sub> = 0°C to 105°C |
|                                                       | −1                        | ±0.062 | +1                | LSB        | V <sub>REFP</sub> = 10 V, V <sub>REFN</sub> = 0 V <sup>3</sup> , T <sub>A</sub> = 0°C to 105°C       |
|                                                       | −1.5                      | ±0.2   | +1.5              | LSB        | V <sub>REFP</sub> = 5 V, V <sub>REFN</sub> = 0 V <sup>3</sup> , T <sub>A</sub> = 0°C to 105°C        |
| Full-Scale Error Temperature Coefficient <sup>3</sup> |                           | ±0.02  |                   | ppm FSR/°C |                                                                                                      |
| Zero-Scale Error                                      | −1.75                     | ±0.025 | +1.75             | LSB        | V <sub>REFP</sub> = +10 V, V <sub>REFN</sub> = −10 V <sup>3</sup>                                    |
|                                                       | −2.5                      | ±0.38  | +2.5              | LSB        | V <sub>REFP</sub> = +10 V, V <sub>REFN</sub> = 0 V <sup>3</sup>                                      |
|                                                       | −5.25                     | ±0.19  | +5.25             | LSB        | V <sub>REFP</sub> = +5 V, V <sub>REFN</sub> = 0 V <sup>3</sup>                                       |
|                                                       | −1                        | ±0.025 | +1                | LSB        | V <sub>REFP</sub> = +10 V, V <sub>REFN</sub> = −10 V <sup>3</sup> ,<br>T <sub>A</sub> = 0°C to 105°C |
|                                                       | −1                        | ±0.38  | +1                | LSB        | V <sub>REFP</sub> = 10 V, V <sub>REFN</sub> = 0 V <sup>3</sup> , T <sub>A</sub> = 0°C to 105°C       |
|                                                       | −1.5                      | ±0.19  | +1.5              | LSB        | V <sub>REFP</sub> = 5 V, V <sub>REFN</sub> = 0 V <sup>3</sup> , T <sub>A</sub> = 0°C to 105°C        |
| Zero-Scale Error Temperature Coefficient <sup>3</sup> |                           | ±0.04  |                   | ppm FSR/°C |                                                                                                      |
| Gain Error                                            | −6                        | ±0.3   | +6                | ppm FSR    | V <sub>REFP</sub> = +10 V, V <sub>REFN</sub> = −10 V <sup>3</sup>                                    |
|                                                       | −10                       | ±0.4   | +10               | ppm FSR    | V <sub>REFP</sub> = +10 V, V <sub>REFN</sub> = 0 V <sup>3</sup>                                      |
|                                                       | −20                       | ±0.4   | +20               | ppm FSR    | V <sub>REFP</sub> = +5 V, V <sub>REFN</sub> = 0 V <sup>3</sup>                                       |
| Gain Error Temperature Coefficient <sup>3</sup>       |                           | ±0.04  |                   | ppm FSR/°C |                                                                                                      |
| R1, R <sub>FB</sub> Matching                          |                           | 0.01   |                   | %          |                                                                                                      |
| OUTPUT CHARACTERISTICS <sup>3</sup>                   |                           |        |                   |            |                                                                                                      |
| Output Voltage Range                                  | V <sub>REFN</sub>         |        | V <sub>REFP</sub> | V          |                                                                                                      |
| Output Slew Rate                                      |                           | 50     |                   | V/μs       | Unbuffered output, 10 MΩ  20 pF load                                                                 |
| Output Voltage Settling Time                          |                           | 1      |                   | μs         | 10 V step to 0.02%, using <a href="#">AD845</a> buffer in unity-gain mode                            |
|                                                       |                           | 1      |                   | μs         | 125 code step to ±1 LSB <sup>6</sup>                                                                 |
| Output Noise Spectral Density                         |                           | 7.5    |                   | nV/√Hz     | at 1 kHz, DAC code = midscale                                                                        |
|                                                       |                           | 7.5    |                   | nV/√Hz     | at 10 kHz, DAC code = midscale                                                                       |
|                                                       |                           | 7.5    |                   | nV/√Hz     | at 100 kHz, DAC code = midscale                                                                      |
| Output Voltage Noise                                  |                           | 1.1    |                   | μV p-p     | DAC code = midscale, 0.1 Hz to 10 Hz bandwidth <sup>7</sup>                                          |

| Parameter                                       | A, B Version <sup>1</sup> |           |                         | Unit            | Test Conditions/Comments                                              |
|-------------------------------------------------|---------------------------|-----------|-------------------------|-----------------|-----------------------------------------------------------------------|
|                                                 | Min                       | Typ       | Max                     |                 |                                                                       |
| Midscale Glitch Impulse                         |                           | 3.1       |                         | nV-sec          | $V_{REFP} = +10\text{ V}$ , $V_{REFN} = -10\text{ V}$                 |
|                                                 |                           | 1.7       |                         | nV-sec          | $V_{REFP} = +10\text{ V}$ , $V_{REFN} = 0\text{ V}$                   |
|                                                 |                           | 1.4       |                         | nV-sec          | $V_{REFP} = +5\text{ V}$ , $V_{REFN} = 0\text{ V}$                    |
| MSB Segment Glitch Impulse <sup>6</sup>         |                           | 9.1       |                         | nV-sec          | $V_{REFP} = +10\text{ V}$ , $V_{REFN} = -10\text{ V}$ , see Figure 43 |
|                                                 |                           | 3.6       |                         | nV-sec          | $V_{REFP} = 10\text{ V}$ , $V_{REFN} = 0\text{ V}$ , see Figure 44    |
|                                                 |                           | 1.9       |                         | nV-sec          | $V_{REFP} = 5\text{ V}$ , $V_{REFN} = 0\text{ V}$ , see Figure 45     |
| Output Enabled Glitch Impulse                   |                           | 45        |                         | nV-sec          | On removal of output ground clamp                                     |
| Digital Feedthrough                             |                           | 0.4       |                         | nV-sec          |                                                                       |
| DC Output Impedance (Normal Mode)               |                           | 3.4       |                         | k $\Omega$      |                                                                       |
| DC Output Impedance (Output Clamped to Ground)  |                           | 6         |                         | k $\Omega$      |                                                                       |
| Spurious Free Dynamic Range                     |                           | 100       |                         | dB              | 1 kHz tone, 10 kHz sample rate                                        |
| Total Harmonic Distortion                       |                           | 97        |                         | dB              | 1 kHz tone, 10 kHz sample rate                                        |
| REFERENCE INPUTS <sup>3</sup>                   |                           |           |                         |                 |                                                                       |
| $V_{REFP}$ Input Range                          | 5                         |           | $V_{DD} - 2.5\text{ V}$ | V               |                                                                       |
| $V_{REFN}$ Input Range                          | $V_{SS} + 2.5\text{ V}$   |           | 0                       |                 |                                                                       |
| DC Input Impedance                              | 5                         | 6.6       |                         | k $\Omega$      | $V_{REFP}$ , $V_{REFN}$ , code dependent, typical at midscale code    |
| Input Capacitance                               |                           | 15        |                         | pF              | $V_{REFP}$ , $V_{REFN}$                                               |
| LOGIC INPUTS <sup>3</sup>                       |                           |           |                         |                 |                                                                       |
| Input Current <sup>8</sup>                      | -1                        |           | +1                      | $\mu\text{A}$   |                                                                       |
| Input Low Voltage, $V_{IL}$                     |                           |           | $0.3 \times IOV_{CC}$   | V               | $IOV_{CC} = 1.71\text{ V}$ to $5.5\text{ V}$                          |
| Input High Voltage, $V_{IH}$                    | $0.7 \times IOV_{CC}$     |           |                         | V               | $IOV_{CC} = 1.71\text{ V}$ to $5.5\text{ V}$                          |
| Pin Capacitance                                 |                           | 5         |                         | pF              |                                                                       |
| LOGIC OUTPUT (SDO) <sup>3</sup>                 |                           |           |                         |                 |                                                                       |
| Output Low Voltage, $V_{OL}$                    |                           |           | 0.4                     | V               | $IOV_{CC} = 1.71\text{ V}$ to $5.5\text{ V}$ , sinking 1 mA           |
| Output High Voltage, $V_{OH}$                   | $IOV_{CC} - 0.5\text{ V}$ |           |                         |                 | $IOV_{CC} = 1.71\text{ V}$ to $5.5\text{ V}$ , sourcing 1 mA          |
| High Impedance Leakage Current                  |                           |           | $\pm 1$                 | $\mu\text{A}$   |                                                                       |
| High Impedance Output Capacitance               |                           | 3         |                         | pF              |                                                                       |
| POWER REQUIREMENTS                              |                           |           |                         |                 |                                                                       |
| $V_{DD}$                                        | 7.5                       |           | $V_{SS} + 33$           | V               | All digital inputs at DGND or $IOV_{CC}$                              |
| $V_{SS}$                                        | $V_{DD} - 33$             |           | -2.5                    | V               |                                                                       |
| $V_{CC}$                                        | 2.7                       |           | 5.5                     | V               |                                                                       |
| $IOV_{CC}$                                      | 1.71                      |           | 5.5                     | V               |                                                                       |
| $I_{DD}$                                        |                           | 4.2       | 5.2                     | mA              | $IOV_{CC} \leq V_{CC}$                                                |
| $I_{SS}$                                        |                           | 4         | 4.9                     | mA              |                                                                       |
| $I_{CC}$                                        |                           | 600       | 900                     | $\mu\text{A}$   |                                                                       |
| $IOI_{CC}$                                      |                           | 52        | 140                     | $\mu\text{A}$   |                                                                       |
| DC Power Supply Rejection Ratio <sup>3, 9</sup> |                           | $\pm 0.6$ |                         | $\mu\text{V/V}$ | SDO disabled<br>$V_{DD} \pm 10\%$ , $V_{SS} = 15\text{ V}$            |
|                                                 |                           | $\pm 0.6$ |                         | $\mu\text{V/V}$ | $V_{SS} \pm 10\%$ , $V_{DD} = 15\text{ V}$                            |
| AC Power Supply Rejection Ratio <sup>3</sup>    |                           | 95        |                         | dB              | $V_{DD} \pm 200\text{ mV}$ , 50 Hz/60 Hz, $V_{SS} = -15\text{ V}$     |
|                                                 |                           | 95        |                         | dB              | $V_{SS} \pm 200\text{ mV}$ , 50 Hz/60 Hz, $V_{DD} = 15\text{ V}$      |

<sup>1</sup> Temperature range:  $-40^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$ , typical conditions:  $T_A = 25^{\circ}\text{C}$ ,  $V_{DD} = +15\text{ V}$ ,  $V_{SS} = -15\text{ V}$ ,  $V_{REFP} = +10\text{ V}$ ,  $V_{REFN} = -10\text{ V}$ .

<sup>2</sup> Performance characterized with AD8676BRZ voltage reference buffers and AD8675ARZ output buffer.

<sup>3</sup> Linearity error refers to both INL error and DNL error; either parameter can be expected to drift by the amount specified after the length of time specified.

<sup>4</sup> Valid for all voltage reference spans.

<sup>5</sup> Guaranteed by design and characterization, not production tested.

<sup>6</sup> The AD5781 is configured in the bias compensation mode with a low-pass RC filter on the output.  $R = 300\text{ }\Omega$ ,  $C = 143\text{ pF}$  (total capacitance seen by the output buffer, lead capacitance, and so forth).

<sup>7</sup> Includes noise contribution from AD8676BRZ voltage reference buffers.

<sup>8</sup> Current flowing in an individual logic pin.

<sup>9</sup> Includes PSRR of AD8676BRZ voltage reference buffers.

**TIMING CHARACTERISTICS**

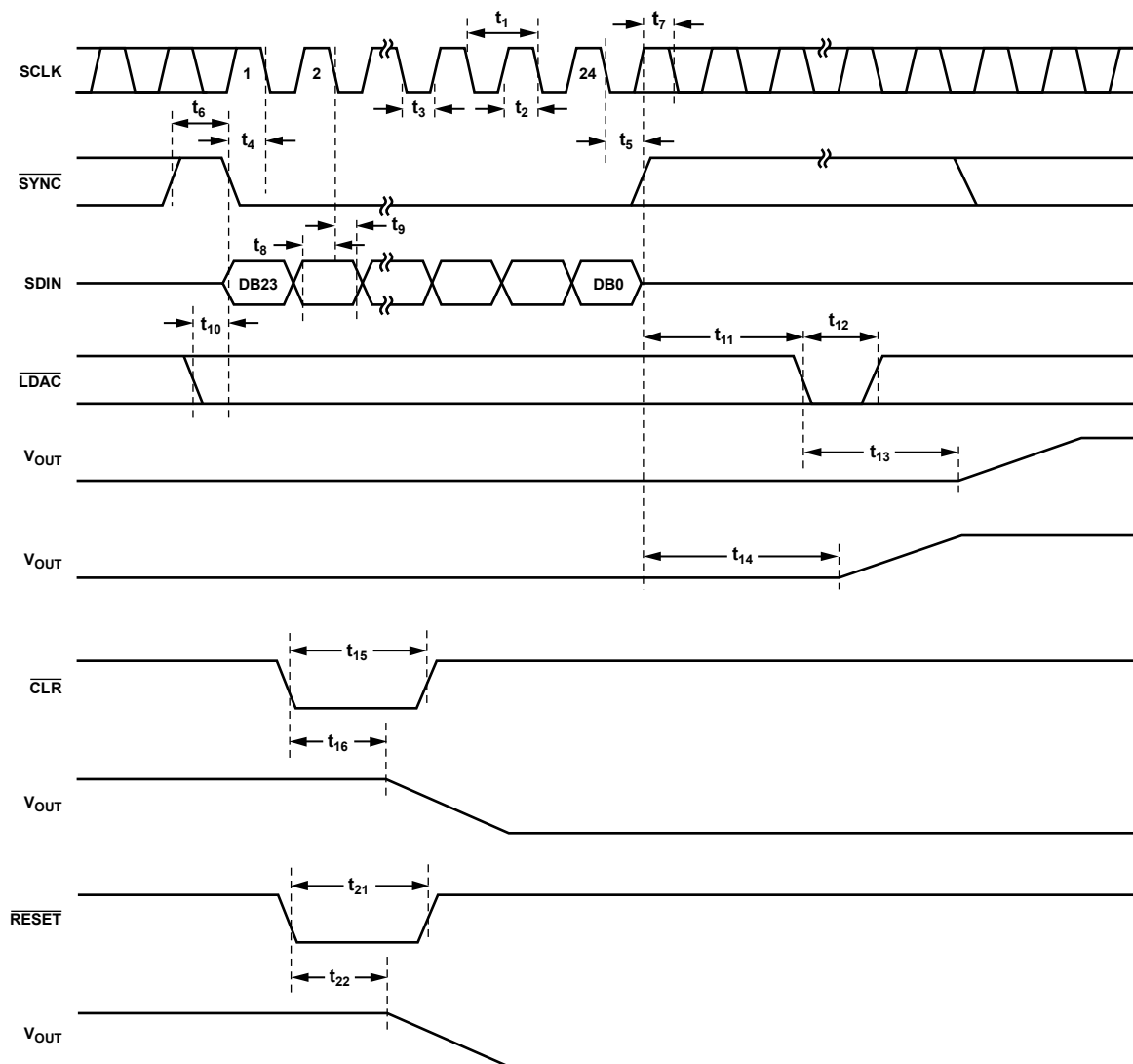
$V_{CC} = 2.7\text{ V to }5.5\text{ V}$ ; all specifications  $T_{MIN}$  to  $T_{MAX}$ , unless otherwise noted.

**Table 4.**

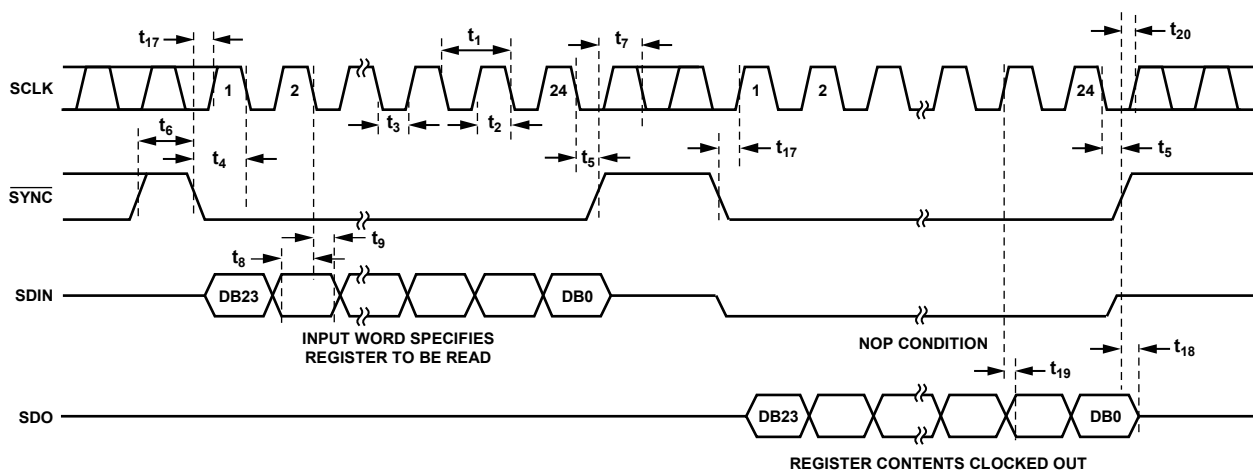
| Parameter | Limit <sup>1</sup>                         |                                           | Unit   | Test Conditions/Comments                                                            |
|-----------|--------------------------------------------|-------------------------------------------|--------|-------------------------------------------------------------------------------------|
|           | $IOV_{CC} = 1.71\text{ V to }3.3\text{ V}$ | $IOV_{CC} = 3.3\text{ V to }5.5\text{ V}$ |        |                                                                                     |
| $t_1^2$   | 40                                         | 28                                        | ns min | SCLK cycle time                                                                     |
|           | 92                                         | 60                                        | ns min | SCLK cycle time (readback and daisy-chain modes)                                    |
| $t_2$     | 15                                         | 10                                        | ns min | SCLK high time                                                                      |
| $t_3$     | 9                                          | 5                                         | ns min | SCLK low time                                                                       |
| $t_4$     | 5                                          | 5                                         | ns min | $\overline{SYNC}$ to SCLK falling edge setup time                                   |
| $t_5$     | 2                                          | 2                                         | ns min | SCLK falling edge to $\overline{SYNC}$ rising edge hold time                        |
| $t_6$     | 48                                         | 40                                        | ns min | Minimum $\overline{SYNC}$ high time                                                 |
| $t_7$     | 8                                          | 6                                         | ns min | $\overline{SYNC}$ rising edge to next SCLK falling edge ignore                      |
| $t_8$     | 9                                          | 7                                         | ns min | Data setup time                                                                     |
| $t_9$     | 12                                         | 7                                         | ns min | Data hold time                                                                      |
| $t_{10}$  | 13                                         | 10                                        | ns min | $\overline{LDAC}$ falling edge to $\overline{SYNC}$ falling edge                    |
| $t_{11}$  | 20                                         | 16                                        | ns min | $\overline{SYNC}$ rising edge to $\overline{LDAC}$ falling edge                     |
| $t_{12}$  | 14                                         | 11                                        | ns min | $\overline{LDAC}$ pulse width low                                                   |
| $t_{13}$  | 130                                        | 130                                       | ns typ | $\overline{LDAC}$ falling edge to output response time                              |
| $t_{14}$  | 130                                        | 130                                       | ns typ | $\overline{SYNC}$ rising edge to output response time ( $\overline{LDAC}$ tied low) |
| $t_{15}$  | 50                                         | 50                                        | ns min | $\overline{CLR}$ pulse width low                                                    |
| $t_{16}$  | 140                                        | 140                                       | ns typ | $\overline{CLR}$ pulse activation time                                              |
| $t_{17}$  | 0                                          | 0                                         | ns min | $\overline{SYNC}$ falling edge to first SCLK rising edge                            |
| $t_{18}$  | 65                                         | 60                                        | ns max | $\overline{SYNC}$ rising edge to SDO tristate ( $C_L = 50\text{ pF}$ )              |
| $t_{19}$  | 62                                         | 45                                        | ns max | SCLK rising edge to SDO valid ( $C_L = 50\text{ pF}$ )                              |
| $t_{20}$  | 0                                          | 0                                         | ns min | $\overline{SYNC}$ rising edge to SCLK rising edge ignore                            |
| $t_{21}$  | 35                                         | 35                                        | ns typ | $\overline{RESET}$ pulse width low                                                  |
| $t_{22}$  | 150                                        | 150                                       | ns typ | $\overline{RESET}$ pulse activation time                                            |

<sup>1</sup> All input signals are specified with  $t_R = t_F = 1\text{ ns/V}$  (10% to 90% of  $IOV_{CC}$ ) and timed from a voltage level of  $(V_{IL} + V_{IH})/2$ .

<sup>2</sup> Maximum SCLK frequency is 35 MHz for write mode and 16 MHz for readback and daisy-chain modes.



09092-002



09092-003

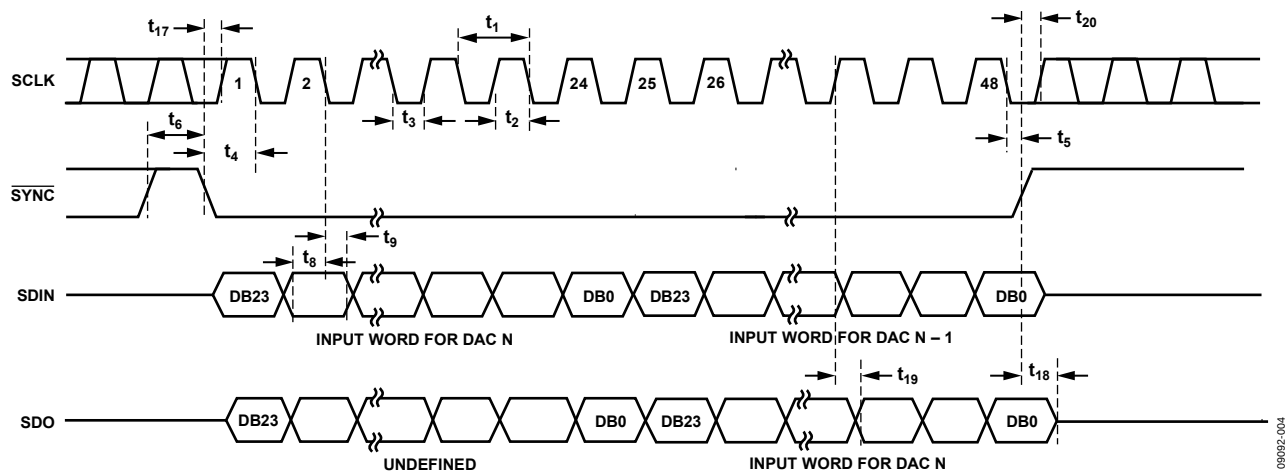


Figure 4. Daisy-Chain Mode Timing Diagram

## ABSOLUTE MAXIMUM RATINGS

$T_A = 25^\circ\text{C}$ , unless otherwise noted. Transient currents of up to 100 mA do not cause SCR latch-up.

Table 5.

| Parameter                                       | Rating                                                                           |
|-------------------------------------------------|----------------------------------------------------------------------------------|
| $V_{DD}$ to AGND                                | $-0.3\text{ V to }+34\text{ V}$                                                  |
| $V_{SS}$ to AGND                                | $-34\text{ V to }+0.3\text{ V}$                                                  |
| $V_{DD}$ to $V_{SS}$                            | $-0.3\text{ V to }+34\text{ V}$                                                  |
| $V_{CC}$ to DGND                                | $-0.3\text{ V to }+7\text{ V}$                                                   |
| $IOV_{CC}$ to DGND                              | $-0.3\text{ V to }V_{CC} + 3\text{ V or }+7\text{ V}$<br>(whichever is less)     |
| Digital Inputs to DGND                          | $-0.3\text{ V to }IOV_{CC} + 0.3\text{ V or }+7\text{ V}$<br>(whichever is less) |
| $V_{OUT}$ to AGND                               | $-0.3\text{ V to }V_{DD} + 0.3\text{ V}$                                         |
| $V_{REFPF}$ to AGND                             | $-0.3\text{ V to }V_{DD} + 0.3\text{ V}$                                         |
| $V_{REFPS}$ to AGND                             | $-0.3\text{ V to }V_{DD} + 0.3\text{ V}$                                         |
| $V_{REFNF}$ to AGND                             | $V_{SS} - 0.3\text{ V to }+0.3\text{ V}$                                         |
| $V_{REFNS}$ to AGND                             | $V_{SS} - 0.3\text{ V to }+0.3\text{ V}$                                         |
| DGND to AGND                                    | $-0.3\text{ V to }+0.3\text{ V}$                                                 |
| Operating Temperature Range, $T_A$              |                                                                                  |
| Industrial                                      | $-40^\circ\text{C to }+125^\circ\text{C}$                                        |
| Storage Temperature Range                       | $-65^\circ\text{C to }+150^\circ\text{C}$                                        |
| Maximum Junction Temperature, $T_{J\text{max}}$ | $150^\circ\text{C}$                                                              |
| Power Dissipation                               | $(T_{J\text{max}} - T_A)/\theta_{JA}$                                            |
| TSSOP Package                                   |                                                                                  |
| $\theta_{JA}$ Thermal Impedance                 | $143^\circ\text{C/W}$                                                            |
| $\theta_{JC}$ Thermal Impedance                 | $45^\circ\text{C/W}$                                                             |
| Lead Temperature                                | JEDEC industry standard                                                          |
| Soldering                                       | J-STD-020                                                                        |
| ESD (Human Body Model)                          | $1.5\text{ kV}$                                                                  |

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

This device is a high performance integrated circuit with an ESD rating of 1.5 kV, and it is ESD sensitive. Proper precautions should be taken for handling and assembly.

### ESD CAUTION



**ESD (electrostatic discharge) sensitive device.** Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

## PIN CONFIGURATION AND FUNCTION DESCRIPTION

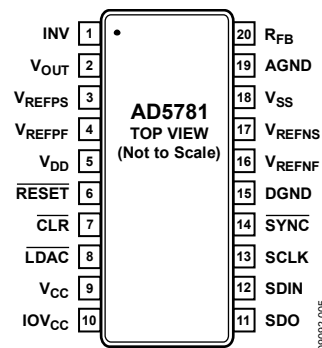


Table 6. Pin Function Descriptions

| Pin No. | Mnemonic           | Description                                                                                                                                                                                                                                                                                                                                                                                |
|---------|--------------------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 1       | INV                | Connection to Inverting Input of External Amplifier. See the AD5781 Features section for further details.                                                                                                                                                                                                                                                                                  |
| 2       | V <sub>OUT</sub>   | Analog Output Voltage.                                                                                                                                                                                                                                                                                                                                                                     |
| 3       | V <sub>REFPS</sub> | Positive Reference Sense Voltage Input. A voltage range of 5 V to V <sub>DD</sub> – 2.5 V can be connected. A unity gain amplifier must be connected at this pin, in conjunction with the V <sub>REFPF</sub> pin. See the AD5781 Features section for further details.                                                                                                                     |
| 4       | V <sub>REFPF</sub> | Positive Reference Force Voltage Input. A voltage range of 5 V to V <sub>DD</sub> – 2.5 V can be connected. A unity gain amplifier must be connected at these pin, in conjunction with the V <sub>REFPS</sub> pin. See AD5781 Features section for further details.                                                                                                                        |
| 5       | V <sub>DD</sub>    | Positive Analog Supply Connection. A voltage range of 7.5 V to 16.5 V can be connected. V <sub>DD</sub> should be decoupled to AGND.                                                                                                                                                                                                                                                       |
| 6       | RESET              | Active Low Reset Logic Input Pin. Asserting this pin returns the AD5781 to its power-on status.                                                                                                                                                                                                                                                                                            |
| 7       | CLR                | Active Low Clear Logic Input Pin. Asserting this pin sets the DAC register to a user defined value (see Table 13) and updates the DAC output. The output value depends on the DAC register coding that is being used, either binary or twos complement.                                                                                                                                    |
| 8       | LDAC               | Active Low Load DAC Logic Input Pin. This is used to update the DAC register and, consequently, the analog output. When tied permanently low, the output is updated on the rising edge of SYNC. If LDAC is held high during the write cycle, the input register is updated, but the output update is held off until the falling edge of LDAC. The LDAC pin should not be left unconnected. |
| 9       | V <sub>CC</sub>    | Digital Supply Connection. A voltage in the range of 2.7 V to 5.5 V can be connected. V <sub>CC</sub> should be decoupled to DGND.                                                                                                                                                                                                                                                         |
| 10      | IOV <sub>CC</sub>  | Digital Interface Supply Pin. Digital threshold levels are referenced to the voltage applied to this pin. A voltage range of 1.71 V to 5.5 V can be connected. IOV <sub>CC</sub> should not be allowed to exceed V <sub>CC</sub> .                                                                                                                                                         |
| 11      | SDO                | Serial Data Output Pin. Data is clocked out on the rising edge of the serial clock input.                                                                                                                                                                                                                                                                                                  |
| 12      | SDIN               | Serial Data Input Pin. This device has a 24-bit shift register. Data is clocked into the register on the falling edge of the serial clock input.                                                                                                                                                                                                                                           |
| 13      | SCLK               | Serial Clock Input. Data is clocked into the input shift register on the falling edge of the serial clock input. Data can be transferred at clock rates of up to 35 MHz.                                                                                                                                                                                                                   |
| 14      | SYNC               | Active Low Digital Interface Synchronization Input Pin. This is the frame synchronization signal for the input data. When SYNC is low, it enables the input shift register, and data is then transferred in on the falling edges of the following clocks. The input shift register is updated on the rising edge of SYNC.                                                                  |
| 15      | DGND               | Ground Reference Pin for Digital Circuitry.                                                                                                                                                                                                                                                                                                                                                |
| 16      | V <sub>REFNF</sub> | Negative Reference Force Voltage Input. A voltage range of V <sub>SS</sub> + 2.5 V to 0 V can be connected. A unity gain amplifier must be connected at this pin, in conjunction with the V <sub>REFNS</sub> pin. See the AD5781 Features section for further details.                                                                                                                     |
| 17      | V <sub>REFNS</sub> | Negative Reference Sense Voltage Input. A voltage range of V <sub>SS</sub> + 2.5 V to 0 V can be connected. A unity gain amplifier must be connected at these pin, in conjunction with the V <sub>REFNF</sub> pin. See the AD5781 Features section for further details.                                                                                                                    |
| 18      | V <sub>SS</sub>    | Negative Analog Supply Connection. A voltage range of –16.5 V to –2.5 V can be connected. V <sub>SS</sub> should be decoupled to AGND.                                                                                                                                                                                                                                                     |
| 19      | AGND               | Ground Reference Pin for Analog Circuitry.                                                                                                                                                                                                                                                                                                                                                 |
| 20      | R <sub>FB</sub>    | Feedback Connection for External Amplifier. See the AD5781 Features section for further details.                                                                                                                                                                                                                                                                                           |

## TYPICAL PERFORMANCE CHARACTERISTICS

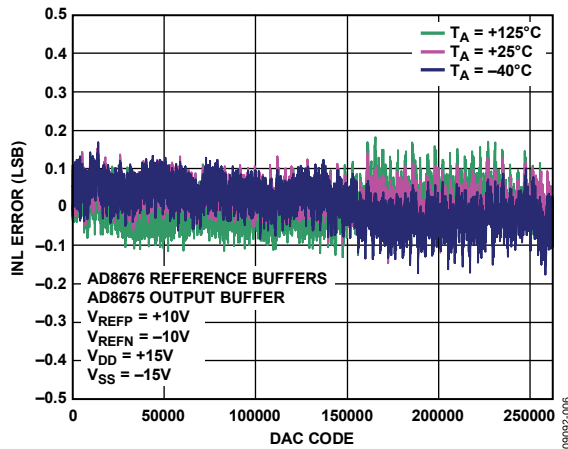
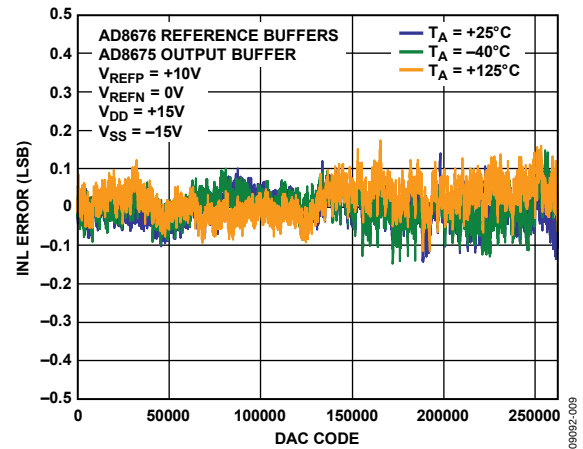
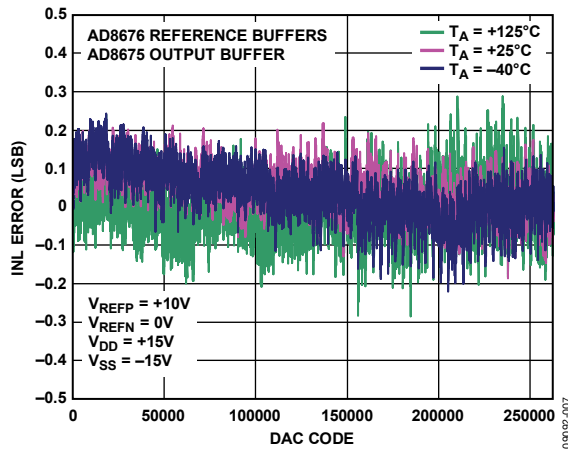
Figure 6. Integral Nonlinearity Error vs. DAC Code,  $\pm 10$  V SpanFigure 9. Integral Nonlinearity Error vs. DAC Code,  $\pm 10$  V Span, X2 Gain Mode

Figure 7. Integral Nonlinearity Error vs. DAC Code, +10 V Span

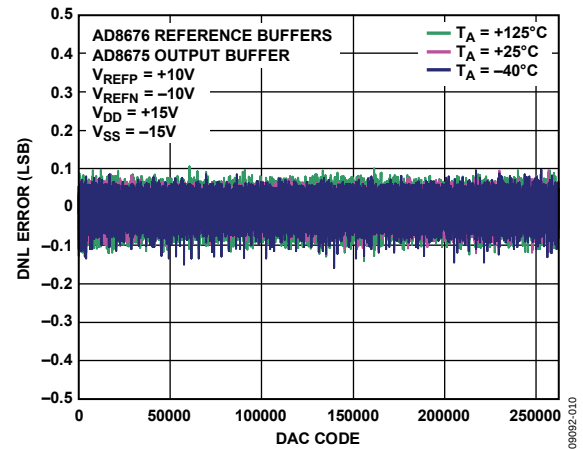
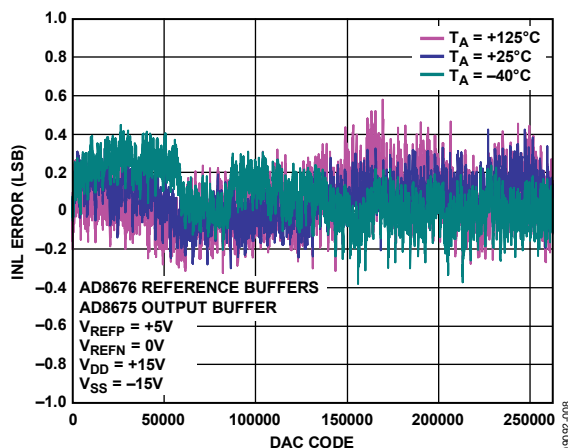
Figure 10. Differential Nonlinearity Error vs. DAC Code,  $\pm 10$  V Span

Figure 8. Integral Nonlinearity Error vs. DAC Code, +5 V Span

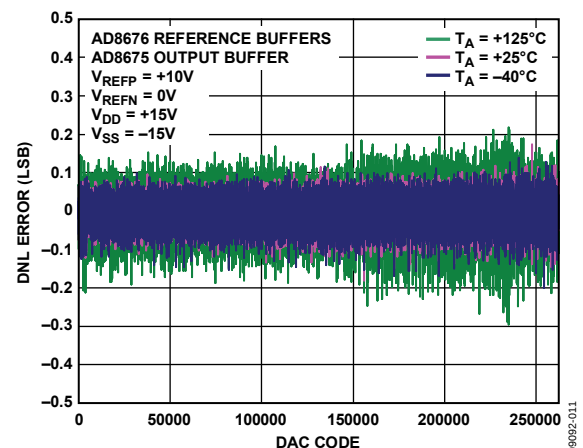


Figure 11. Differential Nonlinearity Error vs. DAC Code, +10 V Span

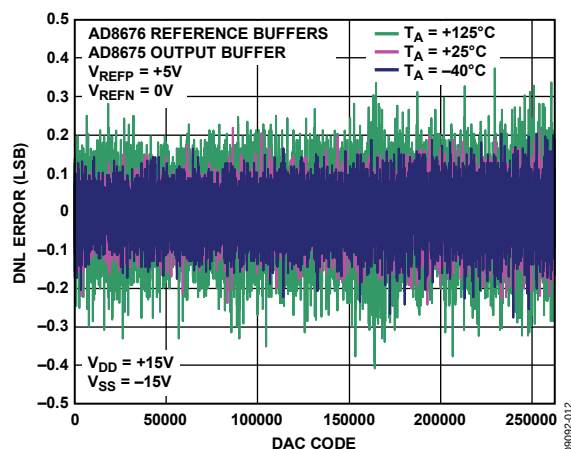


Figure 12. Differential Nonlinearity Error vs. DAC Code, +5 V Span

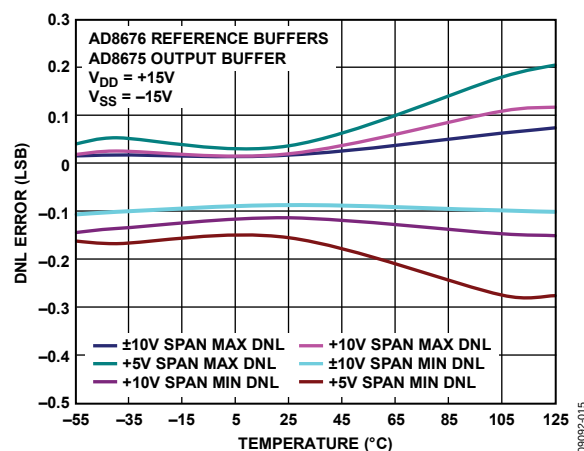


Figure 15. Differential Nonlinearity Error vs. Temperature

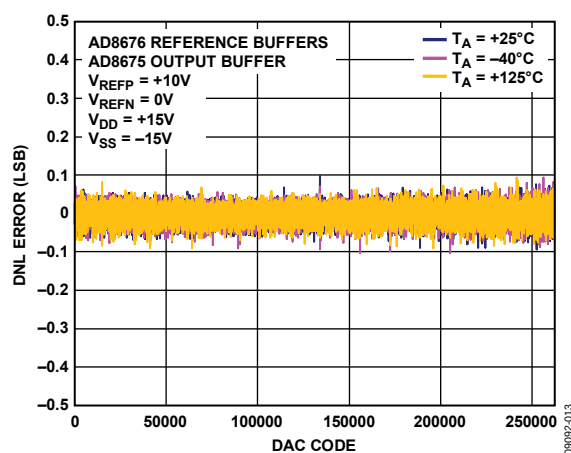


Figure 13. Differential Nonlinearity Error vs. DAC Code, ±10V Span, X2 Gain Mode

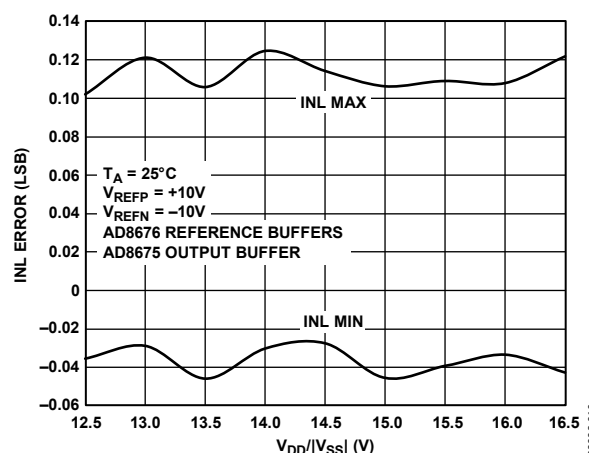


Figure 16. Integral Nonlinearity Error vs. Supply Voltage, ±10 V Span

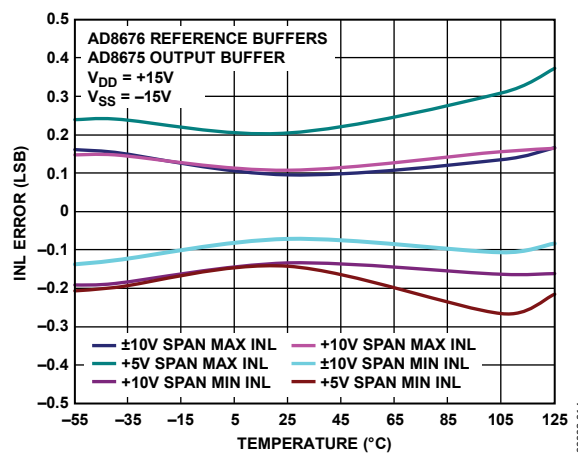


Figure 14. Integral Nonlinearity Error vs. Temperature

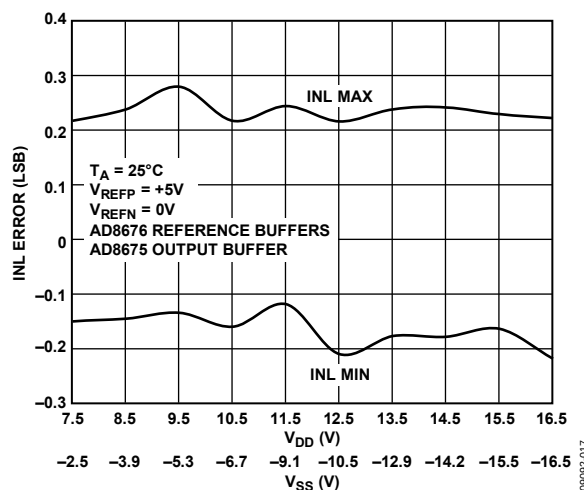


Figure 17. Integral Nonlinearity Error vs. Supply Voltage, +5 V Span

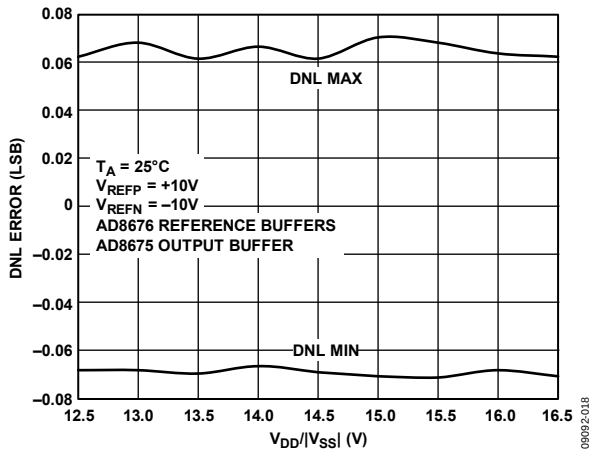
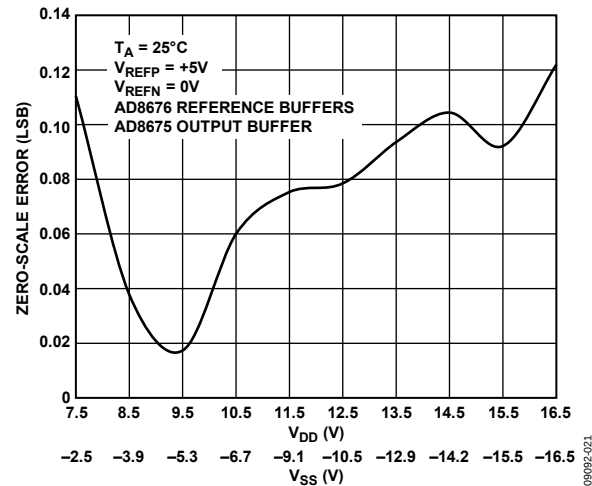
Figure 18. Differential Nonlinearity Error vs. Supply Voltage,  $\pm 10$  V Span

Figure 21. Zero-Scale Error vs. Supply Voltage, +5 V Span

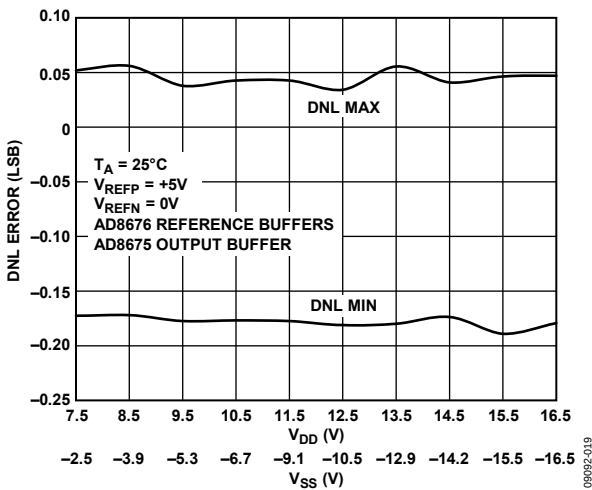


Figure 19. Differential Nonlinearity Error vs. Supply Voltage, +5 V Span

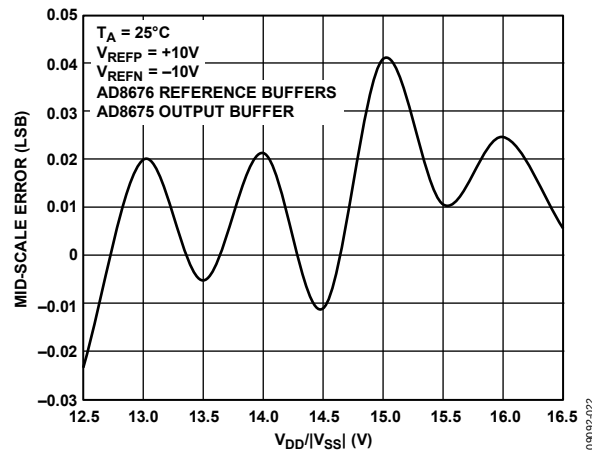
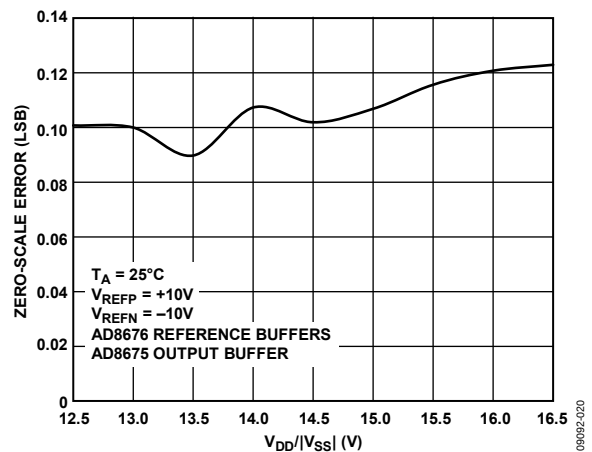
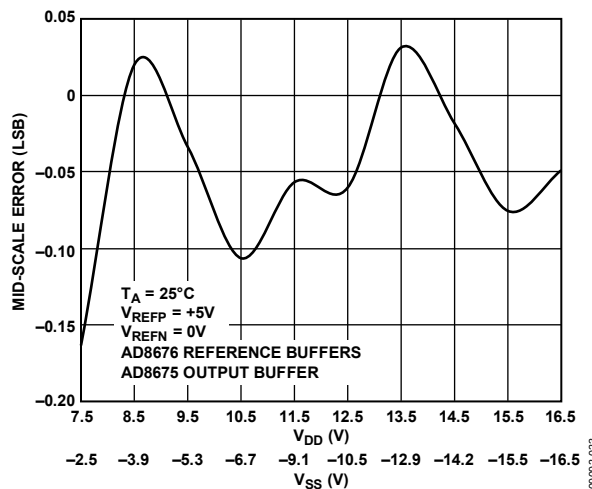
Figure 22. Midscale Error vs. Supply Voltage,  $\pm 10$  V SpanFigure 20. Zero-Scale Error vs. Supply Voltage,  $\pm 10$  V Span

Figure 23. Midscale Error vs. Supply Voltage, +5 V Span

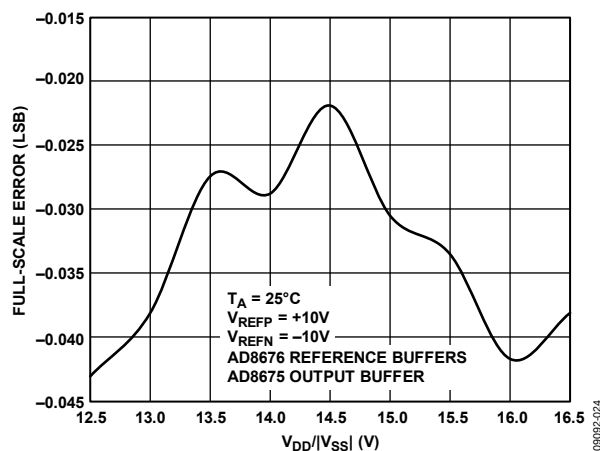
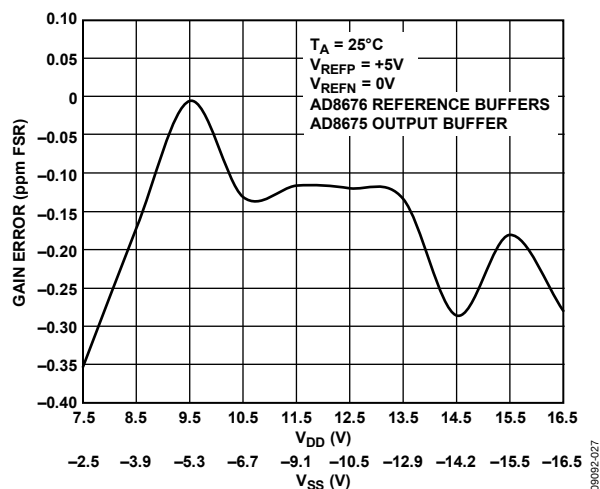
Figure 24. Full-Scale Error vs. Supply Voltage,  $\pm 10$  V Span

Figure 27. Gain Error vs. Supply Voltage, +5 V Span

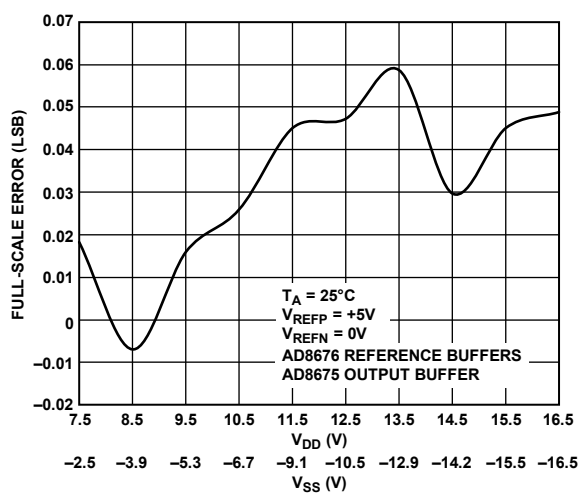


Figure 25. Full-Scale Error vs. Supply Voltage, +5 V Span

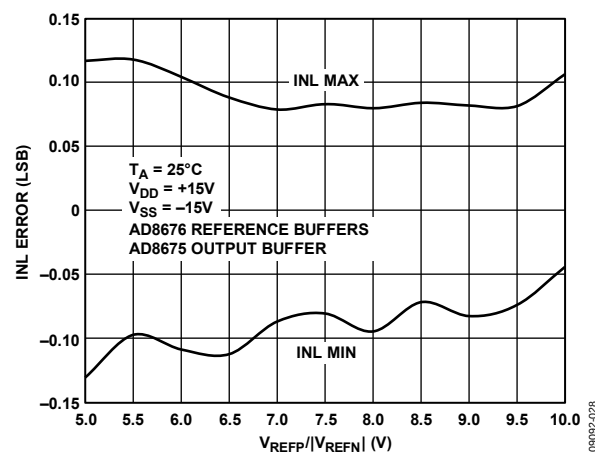


Figure 28. Integral Nonlinearity Error vs. Reference Voltage

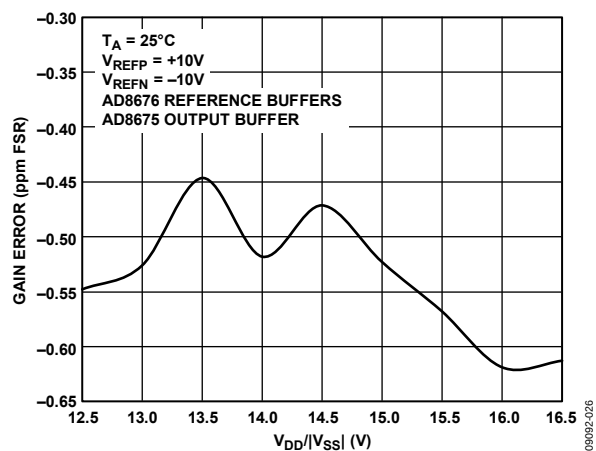
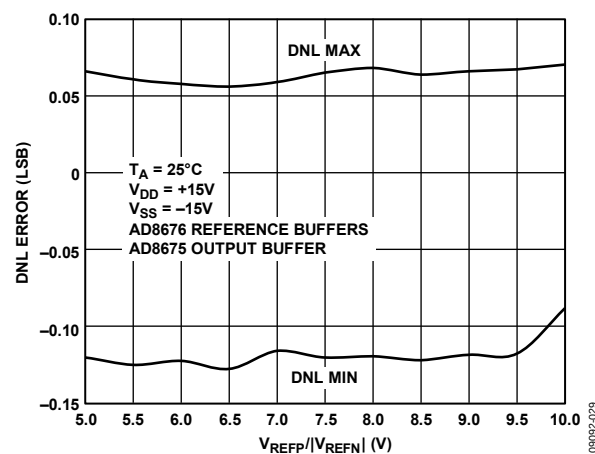
Figure 26. Gain Error vs. Supply Voltage,  $\pm 10$  V Span

Figure 29. Differential Nonlinearity Error vs. Reference Voltage

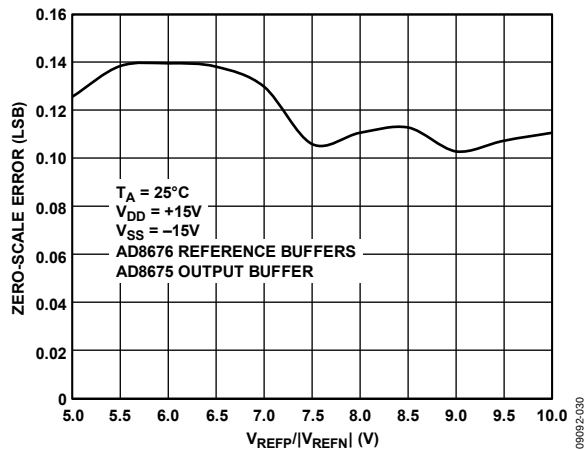


Figure 30. Zero-Scale Error vs. Reference Voltage

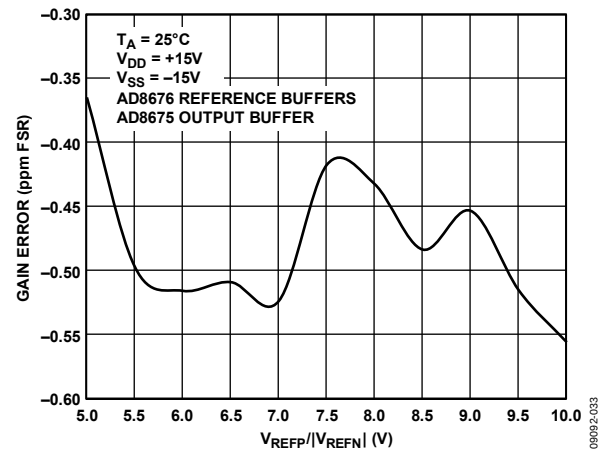


Figure 33. Gain Error vs. Reference Voltage

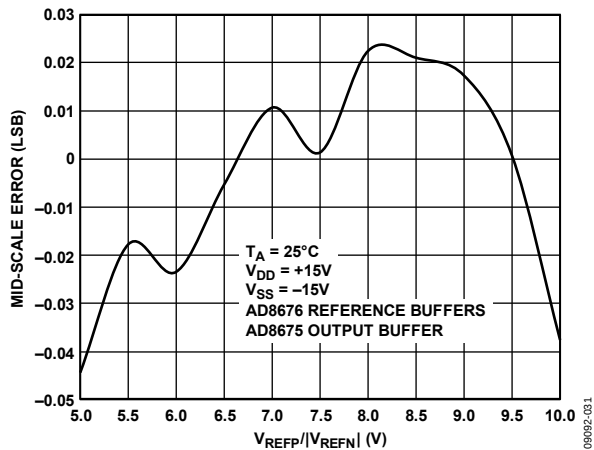


Figure 31. Midscale Error vs. Reference Voltage

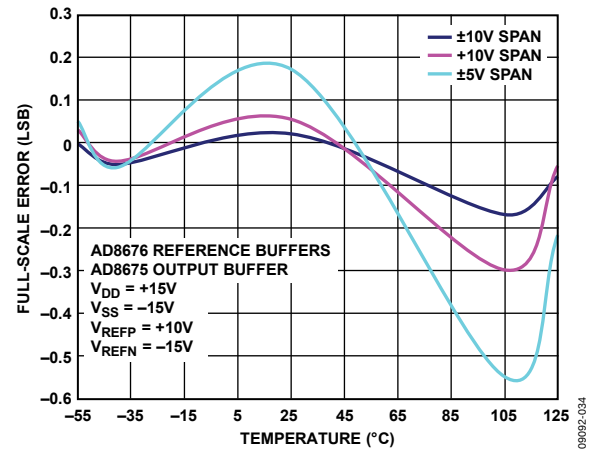


Figure 34. Full-Scale Error vs. Temperature

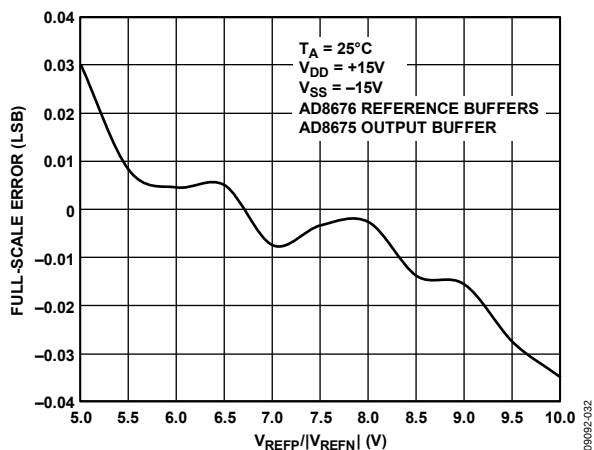


Figure 32. Full-Scale Error vs. Reference Voltage

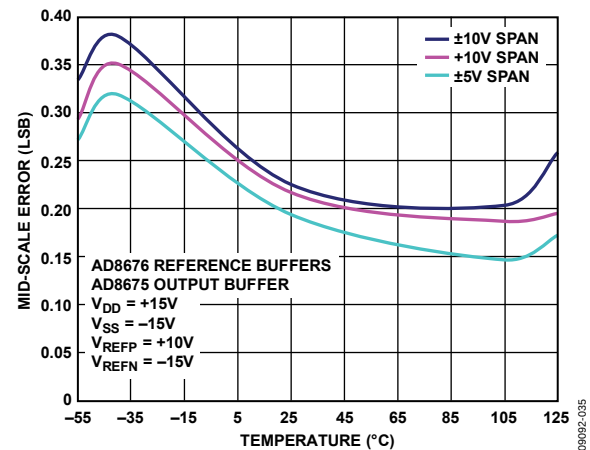


Figure 35. Midscale Error vs. Temperature

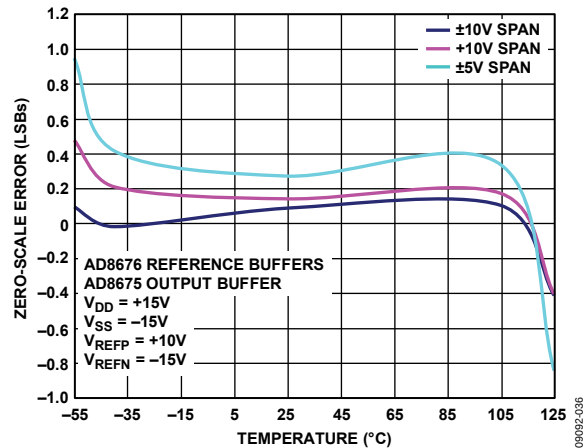


Figure 36. Zero-Scale Error vs. Temperature

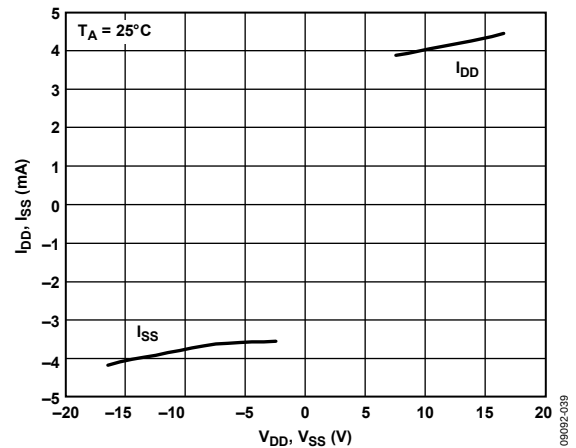


Figure 39. Power Supply Currents vs. Power Supply Voltages

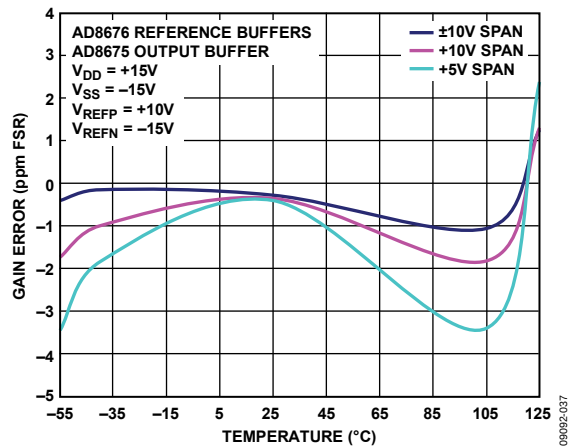


Figure 37. Gain Error vs. Temperature

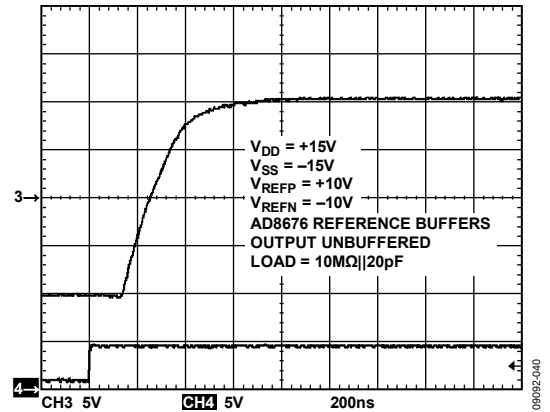


Figure 40. Rising Full-Scale Voltage Step

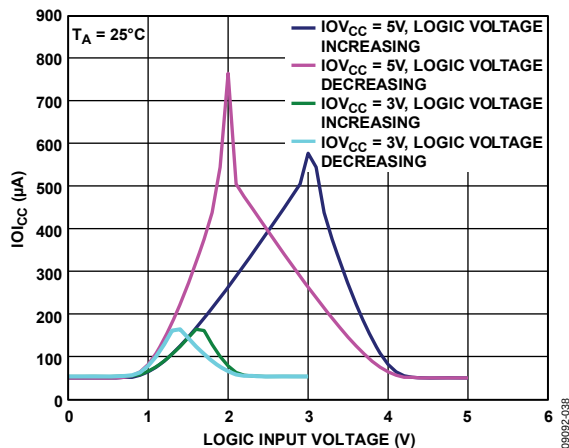
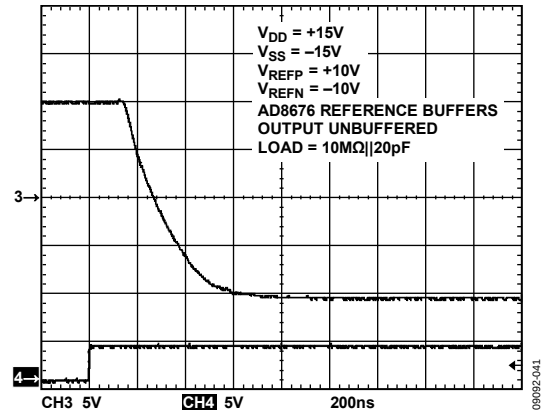
Figure 38.  $I_{OI\_CC}$  vs. Logic Input Voltage

Figure 41. Falling Full-Scale Voltage Step

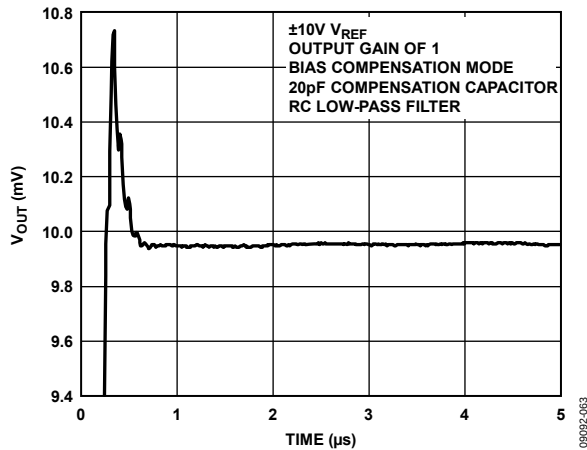


Figure 42. 125 Code Step Settling Time

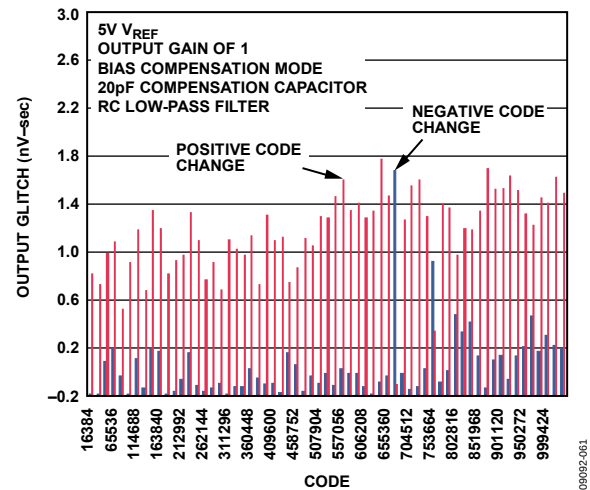
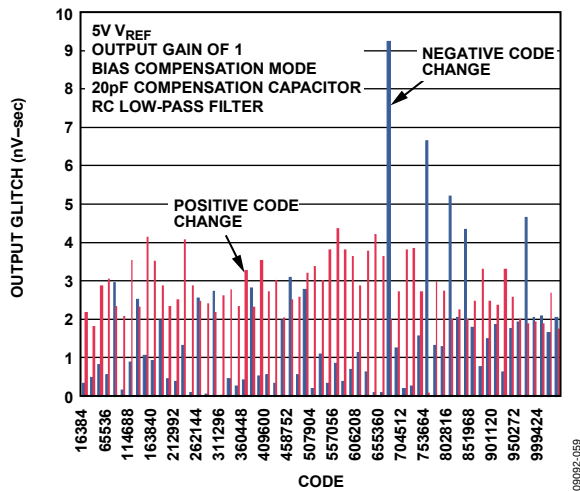
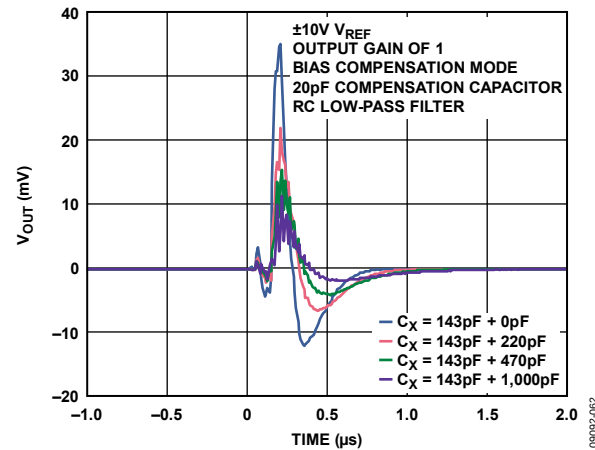
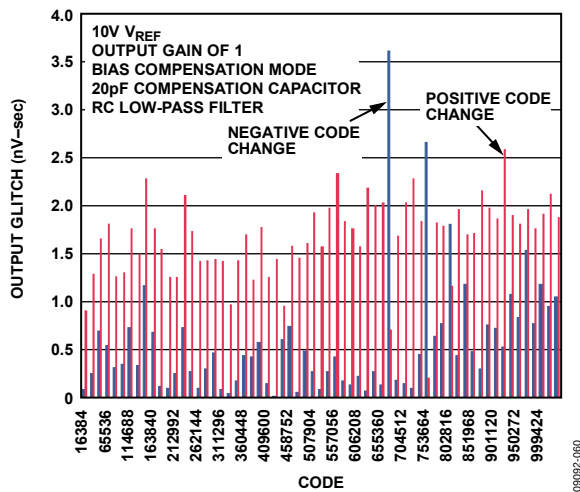
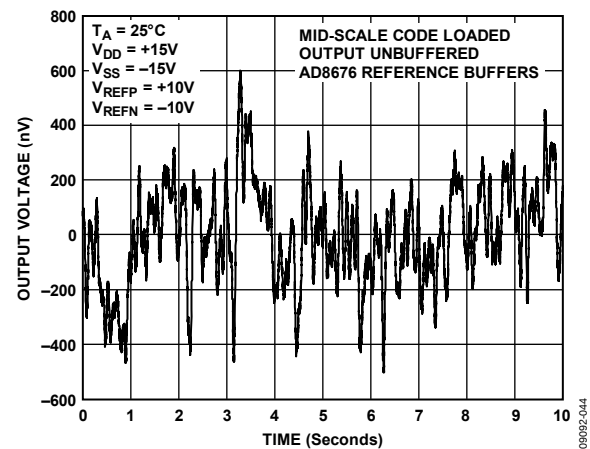
Figure 45. 6 MSB Segment Glitch Energy for 5 V<sub>REF</sub>Figure 43. 6 MSB Segment Glitch Energy for  $\pm 10$  V<sub>REF</sub>Figure 46. Midscale Peak-to-Peak Glitch for  $\pm 10$  VFigure 44. 6 MSB Segment Glitch Energy for 10 V<sub>REF</sub>

Figure 47. Voltage Output Noise, 0.1 Hz to 10 Hz Bandwidth

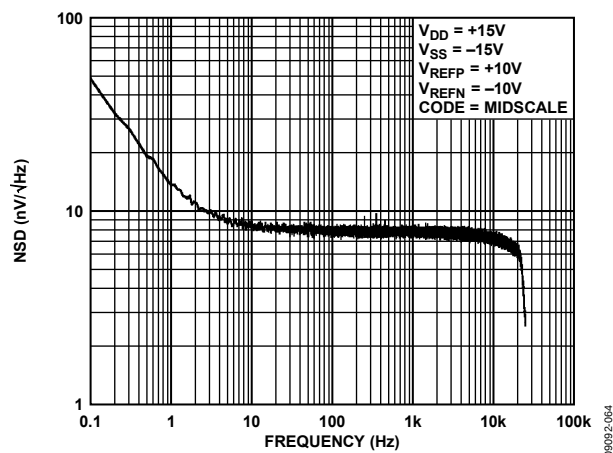


Figure 48. Noise Spectral Density vs. Frequency

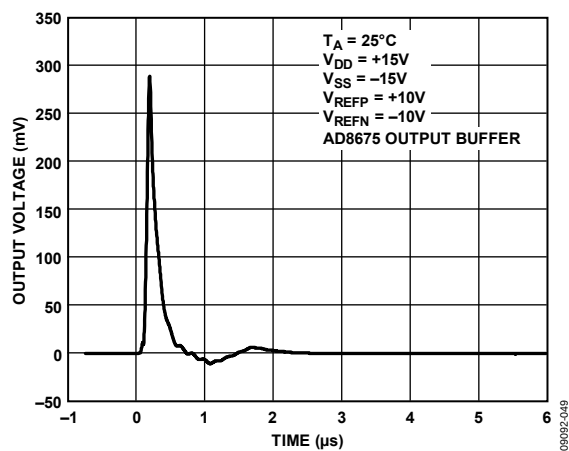


Figure 49. Glitch Impulse on Removal of Output Clamp

## TERMINOLOGY

### Relative Accuracy

Relative accuracy, or integral nonlinearity (INL), is a measure of the maximum deviation, in LSB, from a straight line passing through the endpoints of the DAC transfer function. A typical INL error vs. code plot is shown in Figure 6.

### Differential Nonlinearity (DNL)

Differential nonlinearity is the difference between the measured change and the ideal 1 LSB change between any two adjacent codes. A specified differential nonlinearity of  $\pm 1$  LSB maximum ensures monotonicity. This DAC is guaranteed monotonic. A typical DNL error vs. code plot is shown in Figure 10.

### Linearity Error Long-Term Stability

Linearity error long-term stability is a measure of the stability of the linearity of the DAC over a long period of time. It is specified in LSB for a time period of 500 hours and 1000 hours at an elevated ambient temperature.

### Zero-Scale Error

Zero-scale error is a measure of the output error when zero-scale code (0x00000) is loaded to the DAC register. Ideally, the output voltage should be  $V_{REFNS}$ . Zero-scale error is expressed in LSBs.

### Zero-Scale Error Temperature Coefficient

Zero-scale error temperature coefficient is a measure of the change in zero-scale error with a change in temperature. It is expressed in ppm FSR/ $^{\circ}$ C.

### Full-Scale Error

Full-scale error is a measure of the output error when full-scale code (0x3FFFF) is loaded to the DAC register. Ideally, the output voltage should be  $V_{REFPS} - 1$  LSB. Full-scale error is expressed in LSBs.

### Full-Scale Error Temperature Coefficient

Full-scale error temperature coefficient is a measure of the change in full-scale error with a change in temperature. It is expressed in ppm FSR/ $^{\circ}$ C.

### Gain Error

Gain error is a measure of the span error of the DAC. It is the deviation in slope of the DAC transfer characteristic from ideal, expressed in ppm of the full-scale range.

### Gain Error Temperature Coefficient

Gain error temperature coefficient is a measure of the change in gain error with a change in temperature. It is expressed in ppm FSR/ $^{\circ}$ C.

### Midscale Error

Midscale error is a measure of the output error when midscale code (0x20000) is loaded to the DAC register. Ideally, the output voltage should be  $(V_{REFPS} - V_{REFNS})/2 + V_{REFNS}$ . Midscale error is expressed in LSBs.

### Midscale Error Temperature Coefficient

Midscale error temperature coefficient is a measure of the change in mid-scale error with a change in temperature. It is expressed in ppm FSR/ $^{\circ}$ C.

### Output Slew Rate

Slew rate is a measure of the limitation in the rate of change of the output voltage. The slew rate of the AD5781 output voltage is determined by the capacitive load presented to the  $V_{OUT}$  pin. The capacitive load in conjunction with the 3.4 k $\Omega$  output impedance of the AD5781 set the slew rate. Slew rate is measured from 10% to 90% of the output voltage change and is expressed in V/ $\mu$ s.

### Output Voltage Settling Time

Output voltage settling time is the amount of time it takes for the output voltage to settle to a specified level for a specified change in voltage. For fast settling applications, a high speed buffer amplifier is required to buffer the load from the 3.4 k $\Omega$  output impedance of the AD5781, in which case, it is the amplifier that determines the settling time.

### Digital-to-Analog Glitch Impulse

Digital-to-analog glitch impulse is the impulse injected into the analog output when the input code in the DAC register changes state. It is specified as the area of the glitch in nV-sec and is measured when the digital input code is changed by 1 LSB at the major carry transition (see Figure 43).

### Output Enabled Glitch Impulse

Output enabled glitch impulse is the impulse injected into the analog output when the clamp to ground on the DAC output is removed. It is specified as the area of the glitch in nV-sec (see Figure 49).

### Digital Feedthrough

Digital feedthrough is a measure of the impulse injected into the analog output of the DAC from the digital inputs of the DAC but is measured when the DAC output is not updated. It is specified in nV-sec and measured with a full-scale code change on the data bus, that is, from all 0s to all 1s, and vice versa.

### Spurious Free Dynamic Range (SFDR)

Spurious free dynamic range is the usable dynamic range of a DAC before spurious noise interferes or distorts the fundamental signal. It is measured by the difference in amplitude between the fundamental and the largest harmonically or nonharmonically related spur from dc to full Nyquist bandwidth (half the DAC sampling rate, or  $f_s/2$ ). SFDR is measured when the signal is a digitally generated sine wave.

### Total Harmonic Distortion (THD)

Total harmonic distortion is the ratio of the rms sum of the harmonics of the DAC output to the fundamental value. Only the second to fifth harmonics are included.

**DC Power Supply Rejection Ratio.**

DC power supply rejection ratio is a measure of the rejection of the output voltage to dc changes in the power supplies applied to the DAC. It is measured for a given dc change in power supply voltage and is expressed in  $\mu\text{V}/\text{V}$ .

**AC Power Supply Rejection Ratio (AC PSRR)**

AC power supply rejection ratio is a measure of the rejection of the output voltage to ac changes in the power supplies applied to the DAC. It is measured for a given amplitude and frequency change in power supply voltage and is expressed in decibels.

## THEORY OF OPERATION

The **AD5781** is a high accuracy, fast settling, single, 18-bit, serial input, voltage output DAC. It operates from a  $V_{DD}$  supply voltage of 7.5 V to 16.5 V and a  $V_{SS}$  supply of  $-16.5$  V to  $-2.5$  V. Data is written to the **AD5781** in a 24-bit word format via a 3-wire serial interface. The **AD5781** incorporates a power-on reset circuit that ensures the DAC output powers up to 0 V with the  $V_{OUT}$  pin clamped to AGND through a  $\sim 6$  k $\Omega$  internal resistor.

### DAC ARCHITECTURE

The architecture of the **AD5781** consists of two matched DAC sections. A simplified circuit diagram is shown in Figure 50. The six MSBs of the 18-bit data-word are decoded to drive 63 switches, E0 to E62. Each of these switches connects one of 63 matched resistors to either the  $V_{REFP}$  or  $V_{REFN}$  voltage. The remaining 12 bits of the data-word drive the S0 to S11 switches of a 12-bit voltage mode R-R ladder network.

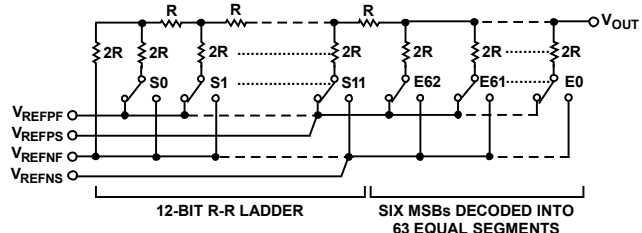


Figure 50. DAC Ladder Structure Serial Interface

The **AD5781** has a 3-wire serial interface ( $\overline{\text{SYNC}}$ , SCLK, and SDIN) that is compatible with SPI, QSPI, and MICROWIRE interface standards, as well as most DSPs (see Figure 2 for a timing diagram).

### Input Shift Register

The input shift register is 24 bits wide. Data is loaded into the device MSB first as a 24-bit word under the control of a serial clock input, SCLK, which can operate at up to 35 MHz. The input register consists of a R/W bit, three address bits, and twenty data bits as shown in Table 7. The timing diagram for this operation is shown in Figure 2.

Table 7. Input Shift Register Format

| MSB  |                  |      |      |               | LSB |  |
|------|------------------|------|------|---------------|-----|--|
| DB23 | DB22             | DB21 | DB20 | DB19          | DB0 |  |
| R/W  | Register address |      |      | Register data |     |  |

Table 8. Decoding the Input Shift Register

| R/W            | Register Address |   |   | Description                                      |
|----------------|------------------|---|---|--------------------------------------------------|
| X <sup>1</sup> | 0                | 0 | 0 | No operation (NOP). Used in readback operations. |
| 0              | 0                | 0 | 1 | Write to the DAC register.                       |
| 0              | 0                | 1 | 0 | Write to the control register.                   |
| 0              | 0                | 1 | 1 | Write to the clearcode register.                 |
| 0              | 1                | 0 | 0 | Write to the software control register.          |
| 1              | 0                | 0 | 1 | Read from the DAC register.                      |
| 1              | 0                | 1 | 0 | Read from the control register.                  |
| 1              | 0                | 1 | 1 | Read from the clearcode register.                |

<sup>1</sup> X is don't care.

### Standalone Operation

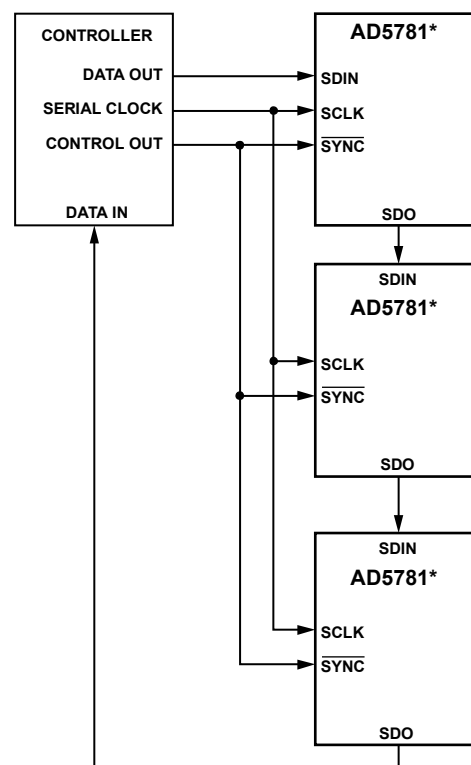
The serial interface works with both a continuous and noncontinuous serial clock. A continuous SCLK source can be used only if SYNC is held low for the correct number of clock cycles. In gated clock mode, a burst clock containing the exact number of clock cycles must be used, and SYNC must be taken high after the final clock to latch the data. The first falling edge of SYNC starts the write cycle. Exactly 24 falling clock edges must be applied to SCLK before SYNC is brought high again. If SYNC is brought high before the 24<sup>th</sup> falling SCLK edge, the data written is invalid. If more than 24 falling SCLK edges are applied before SYNC is brought high, the input data is also invalid. The input shift register is updated on the rising edge of SYNC. For another serial transfer to take place, SYNC must be brought low again. After the end of the serial data transfer, data is automatically transferred from the input shift register to the addressed register. Once the write cycle is complete, the output can be updated by taking LDAC low while SYNC is high.

### Daisy-Chain Operation

For systems that contain several devices, the SDO pin can be used to daisy chain several devices together. Daisy-chain mode can be useful in system diagnostics and in reducing the number of serial interface lines. The first falling edge of SYNC starts the write cycle. SCLK is continuously applied to the input shift register when SYNC is low. If more than 24 clock pulses are applied, the data ripples out of the shift register and appears on the SDO line. This data is clocked out on the rising edge of SCLK and is valid on the falling edge. By connecting the SDO of the first device to the SDIN input of the next device in the chain, a multidevice interface is constructed. Each device in the system requires 24 clock pulses. Therefore, the total number of clock cycles must equal  $24 \times N$ , where  $N$  is the total number of AD5781 devices in the chain. When the serial transfer to all devices is complete, SYNC is taken high. This latches the input data in each device in the daisy chain and prevents any further data from being clocked into the input shift register. The serial clock can be a continuous or a gated clock.

A continuous SCLK source can be used only if SYNC is held low for the correct number of clock cycles. In gated clock mode, a burst clock containing the exact number of clock cycles must be used, and SYNC must be taken high after the final clock to latch the data.

In any one daisy-chain sequence, writes to the DAC register should not be mixed with writes to any of the other registers. All writes to the daisy-chained parts should be either writes to the DAC registers or writes to the control, clearcode, or software control register.



\*ADDITIONAL PINS OMITTED FOR CLARITY.

Figure 51. Daisy-Chain Block Diagram

### Readback

The contents of all the on-chip registers can be read back via the SDO pin. Table 8 outlines how the registers are decoded. After a register has been addressed for a read, the next 24 clock cycles clock the data out on the SDO pin. The clocks must be applied while SYNC is low. When SYNC is returned high, the SDO pin is placed in tristate. For a read of a single register, the NOP function can be used to clock out the data. Alternatively, if more than one register is to be read, the data of the first register to be addressed can be clocked out at the same time the second register to be read is being addressed. The SDO pin must be enabled to complete a readback operation. The SDO pin is enabled by default.

### HARDWARE CONTROL PINS

#### Load DAC Function (LDAC)

After data has been transferred into the input register of the DAC, there are two ways to update the DAC register and DAC output. Depending on the status of both SYNC and LDAC, one of two update modes is selected: synchronous DAC updating or asynchronous DAC updating.

#### Synchronous DAC Update

In this mode, LDAC is held low while data is being clocked into the input shift register. The DAC output is updated on the rising edge of SYNC.

### Asynchronous DAC Update

In this mode,  $\overline{\text{LDAC}}$  is held high while data is being clocked into the input shift register. The DAC output is asynchronously updated by taking  $\overline{\text{LDAC}}$  low after  $\overline{\text{SYNC}}$  has been taken high. The update now occurs on the falling edge of  $\overline{\text{LDAC}}$ .

### Reset Function ( $\overline{\text{RESET}}$ )

The AD5781 can be reset to its power-on state by two means: either by asserting the  $\overline{\text{RESET}}$  pin or by utilizing the software RESET control function (see Table 14). If the  $\overline{\text{RESET}}$  pin is not used, it should be hardwired to  $\text{IOV}_{\text{CC}}$ .

### Asynchronous Clear Function (CLR)

The CLR pin is an active low clear that allows the output to be cleared to a user defined value. The 18-bit clear code value is programmed to the clearcode register (see Table 13). It is necessary to maintain  $\overline{\text{CLR}}$  low for a minimum amount of time to complete the operation (see Figure 2). When the  $\overline{\text{CLR}}$  signal is returned high, the output remains at the clear value (if  $\overline{\text{LDAC}}$  is high) until a new value is loaded to the DAC register. The output cannot be updated with a new value while the  $\overline{\text{CLR}}$  pin is low. A clear operation can also be performed by setting the CLR bit in the software control register (see Table 14).

**Table 9. Hardware Control Pins Truth Table**

| LDAC           | CLR            | RESET | Function                                                                                         |
|----------------|----------------|-------|--------------------------------------------------------------------------------------------------|
| X <sup>1</sup> | X <sup>1</sup> | 0     | The AD5781 is in reset mode. The device cannot be programmed.                                    |
| X <sup>1</sup> | X <sup>1</sup> | ↑     | The AD5781 is returned to its power-on state. All registers are set to their default values.     |
| 0              | 0              | 1     | The DAC register is loaded with the clearcode register value, and the output is set accordingly. |
| 0              | 1              | 1     | The output is set according to the DAC register value.                                           |
| 1              | 0              | 1     | The DAC register is loaded with the clearcode register value, and the output is set accordingly. |
| ↓              | 1              | 1     | The output is set according to the DAC register value.                                           |
| ↓              | 0              | 1     | The output remains at the clear code value.                                                      |
| ↑              | 1              | 1     | The output remains set according to the DAC register value.                                      |
| ↑              | 0              | 1     | The output remains at the clear code value.                                                      |
| 1              | ↓              | 1     | The DAC register is loaded with the clearcode register value and the output is set accordingly.  |
| 0              | ↓              | 1     | The DAC register is loaded with the clearcode register value and the output is set accordingly.  |
| 1              | ↑              | 1     | The output remains at the clear code value.                                                      |
| 0              | ↑              | 1     | The output is set according to the DAC register value.                                           |

<sup>1</sup> X is don't care.

## ON-CHIP REGISTERS

### DAC Register

Table 10 outlines how data is written to and read from the DAC register.

**Table 10. DAC Register**

| MSB                      |                  |      |      |                   |     |     | LSB            |
|--------------------------|------------------|------|------|-------------------|-----|-----|----------------|
| DB23                     | DB22             | DB21 | DB20 | DB19              | DB2 | DB1 | DB0            |
| R/ $\overline{\text{W}}$ | Register address |      |      | DAC register data |     |     |                |
| R/ $\overline{\text{W}}$ | 0                | 0    | 1    | 18-bits of data   |     |     | X <sup>1</sup> |

<sup>1</sup> X is don't care.

The following equation describes the ideal transfer function of the DAC:

$$V_{\text{OUT}} = \frac{(V_{\text{REFP}} - V_{\text{REFN}}) \times D}{2^{18} - 1} + V_{\text{REFN}}$$

where:

$V_{\text{REFN}}$  is the negative voltage applied at the  $V_{\text{REFNS}}$  input pin.

$V_{\text{REFP}}$  is the positive voltage applied at the  $V_{\text{REFPS}}$  input pin.

$D$  is the 18-bit code programmed to the DAC.

**Control Register**

The control register controls the mode of operation of the AD5781.

**Table 11. Control Register**

| MSB  |                  |      |      |                       |          |          |     |     |     |        |         |        |       |      | LSB      |  |
|------|------------------|------|------|-----------------------|----------|----------|-----|-----|-----|--------|---------|--------|-------|------|----------|--|
| DB23 | DB22             | DB21 | DB20 | DB19...DB11           | DB10     | DB9      | DB8 | DB7 | DB6 | DB5    | DB4     | DB3    | DB2   | DB1  | DB0      |  |
| R/W  | Register address |      |      | Control register data |          |          |     |     |     |        |         |        |       |      |          |  |
| R/W  | 0                | 1    | 0    | Reserved              | Reserved | LIN COMP |     |     |     | SDODIS | BIN/2sC | DACTRI | OPGND | RBUF | Reserved |  |

**Table 12. Control Register Functions**

| Function | Description                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                        |
|----------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| Reserved | These bits are reserved and should be programmed to zero.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                          |
| RBUF     | Output amplifier configuration control.<br>0: internal amplifier, A1, is powered up and resistors RFB and R1 are connected in series as shown in Figure 54. This allows an external amplifier to be connected in a gain of two configurations. See the AD5781 Features section for further details.<br>1: (default) internal amplifier, A1, is powered down and resistors RFB and R1 are connected in parallel as shown in Figure 53 so that the resistance between the RFB and INV pins is 3.4 kΩ, equal to the resistance of the DAC. This allows the RFB and INV pins to be used for input bias current compensation for an external unity gain amplifier. See the AD5781 Features section for further details. |
| OPGND    | Output ground clamp control.<br>0: DAC output clamp to ground is removed, and the DAC is placed in normal mode.<br>1: (default) DAC output is clamped to ground through a ~6 kΩ resistance, and the DAC is placed in tristate mode. Resetting the part puts the DAC in OPGND mode, where the output ground clamp is enabled and the DAC is tristated. Setting the OPGND bit to 1 in the control register overrules any write to the DACTRI bit                                                                                                                                                                                                                                                                     |
| DACTRI   | DAC tristate control.<br>0: DAC is in normal operating mode.<br>1: (default) DAC is in tristate mode.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                              |
| BIN/2sC  | DAC register coding select.<br>0: (default) DAC register uses twos complement coding.<br>1: DAC register uses offset binary coding.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                |
| SDODIS   | SDO pin enable/disable control.<br>0: (default) SDO pin is enabled.<br>1: SDO pin is disabled (tristate).                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                          |
| LIN COMP | Linearity error compensation for varying reference input spans. See the AD5781 Features section for further details.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                               |
|          | 0 0 0 0 (Default) reference input span up to 10 V.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                 |
|          | 1 1 0 0 Reference input span of 20 V.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                              |

**Clearcode Register**

The clearcode register sets the value to which the DAC output is set when the  $\overline{\text{CLR}}$  pin or CLR bit is asserted. The output value depends on the DAC coding that is being used, either binary or twos complement. The default register value is 0.

**Table 13. Clearcode Register**

| MSB  |                  |      |      |                 |                         |     |     |                |  | LSB |                |
|------|------------------|------|------|-----------------|-------------------------|-----|-----|----------------|--|-----|----------------|
| DB23 | DB22             | DB21 | DB20 | DB19            | DB2                     | DB1 | DB0 |                |  |     |                |
| R/W  | Register address |      |      |                 | Clearcode register data |     |     |                |  |     |                |
| R/W  | 0                | 1    | 1    | 18-bits of data |                         |     |     | X <sup>1</sup> |  |     | X <sup>1</sup> |

<sup>1</sup> X is don't care.

**Software Control Register**

This is a write only register in which writing a 1 to a particular bit has the same effect as pulsing the corresponding pin low.

**Table 14. Software Control Register**

| MSB  |                  |      |      |                                |     |       | LSB              |                   |
|------|------------------|------|------|--------------------------------|-----|-------|------------------|-------------------|
| DB23 | DB22             | DB21 | DB20 | DB19                           | DB3 | DB2   | DB1              | DB0               |
| R/W  | Register address |      |      | Software control register data |     |       |                  |                   |
| 0    | 1                | 0    | 0    | Reserved                       |     | RESET | CLR <sup>1</sup> | LDAC <sup>2</sup> |

<sup>1</sup> The CLR function has no effect if the  $\overline{\text{LDAC}}$  pin is low.

<sup>2</sup> The LDAC function has no effect if the  $\overline{\text{CLR}}$  pin is low.

**Table 15. Software Control Register Functions**

| Function | Description                                                                                                                                                                                                              |
|----------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| LDAC     | Setting this bit to 1 updates the DAC register and consequently the DAC output.                                                                                                                                          |
| CLR      | Setting this bit to 1 sets the DAC register to a user defined value (see Table 13) and updates the DAC output. The output value depends on the DAC register coding that is being used, either binary or twos complement. |
| RESET    | Setting this bit to 1 returns the <a href="#">AD5781</a> to its power-on state.                                                                                                                                          |

## AD5781 FEATURES

### POWER-ON TO 0 V

The AD5781 contains a power-on reset circuit that, as well as resetting all registers to their default values, controls the output voltage during power-up. Upon power-on, the DAC is placed in tristate (its reference inputs are disconnected), and its output is clamped to AGND through a  $\sim 6\text{ k}\Omega$  resistor. The DAC remains in this state until programmed otherwise via the control register. This is a useful feature in applications where it is important to know the state of the DAC output while it is in the process of powering up.

### CONFIGURING THE AD5781

After power-on, the AD5781 must be configured to put it into normal operating mode before programming the output. To do this, the control register must be programmed. The DAC is removed from tristate by clearing the DACTRI bit, and the output clamp is removed by clearing the OPGND bit. At this point, the output goes to  $V_{REFN}$  unless an alternative value is first programmed to the DAC register.

### DAC OUTPUT STATE

The DAC output can be placed in one of three states, controlled by the DACTRI and OPGND bits of the control register, as shown in Table 16.

Table 16. AD5781 Output State Truth Table

| DACTRI | OPGND | Output State                                           |
|--------|-------|--------------------------------------------------------|
| 0      | 0     | Normal operating mode.                                 |
| 0      | 1     | Output is clamped via $\sim 6\text{ k}\Omega$ to AGND. |
| 1      | 0     | Output is in tristate.                                 |
| 1      | 1     | Output is clamped via $\sim 6\text{ k}\Omega$ to AGND. |

### LINEARITY COMPENSATION

The integral nonlinearity (INL) of the AD5781 can vary according to the applied reference voltage span; the LIN COMP bits of the control register can be programmed to compensate for this variation in INL. The specifications in this data sheet are obtained with LIN COMP = 0000 for reference spans up to and including 10 V and with LIN COMP = 1100 for a reference span of 20 V. The default value of the LIN COMP bits is 0000.

### OUTPUT AMPLIFIER CONFIGURATION

There are a number of different ways that an output amplifier can be connected to the AD5781, depending on the voltage references applied and the desired output voltage span.

#### Unity Gain Configuration

Figure 52 shows an output amplifier configured for unity gain, in this configuration the output spans from  $V_{REFN}$  to  $V_{REFP}$ .

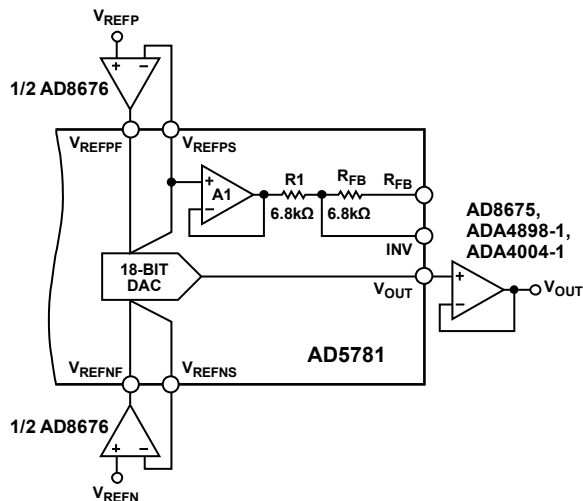


Figure 52. Output Amplifier in Unity Gain Configuration

A second unity gain configuration for the output amplifier is one that removes an offset from the input bias currents of the amplifier. It does this by inserting a resistance in the feedback path of the amplifier that is equal to the output resistance of the DAC. The DAC output resistance is  $3.4\text{ k}\Omega$ . By connecting  $R_1$  and  $R_{FB}$  in parallel, a resistance equal to the DAC resistance is available on-chip. Because the resistors are all on one piece of silicon, they are temperature coefficient matched. To enable this mode of operation, the RBUF bit of the control register must be set to Logic 1. Figure 53 shows how the output amplifier is connected to the AD5781. In this configuration, the output amplifier is in unity gain and the output spans from  $V_{REFN}$  to  $V_{REFP}$ . This unity gain configuration allows a capacitor to be placed in the amplifier feedback path to improve dynamic performance.

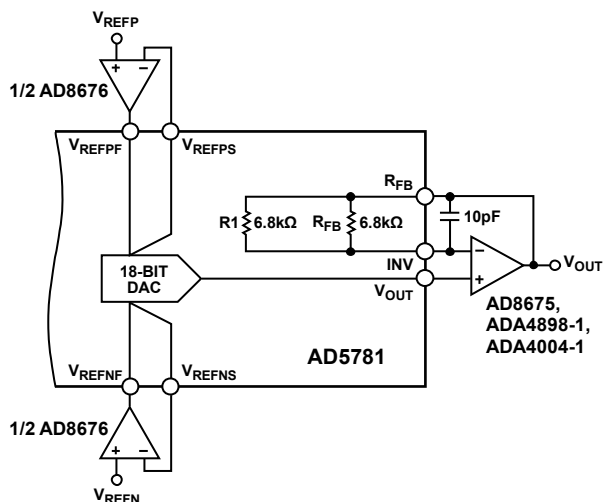


Figure 53. Output Amplifier in Unity Gain with Amplifier Input Bias Current Compensation

### Gain of Two Configuration

Figure 54 shows an output amplifier configured for a gain of two. The gain is set by the internal matched  $6.8\text{ k}\Omega$  resistors, which are exactly twice the DAC resistance, having the effect of removing an offset from the input bias current of the external amplifier. In this configuration, the output spans from  $2 \times V_{\text{REFN}} - V_{\text{REFP}}$  to  $V_{\text{REFP}}$ . This configuration is used to generate a bipolar output span from a single-ended reference input, with  $V_{\text{REFN}} = 0\text{ V}$ . For this mode of operation, the RBUF bit of the control register must be cleared to Logic 0.

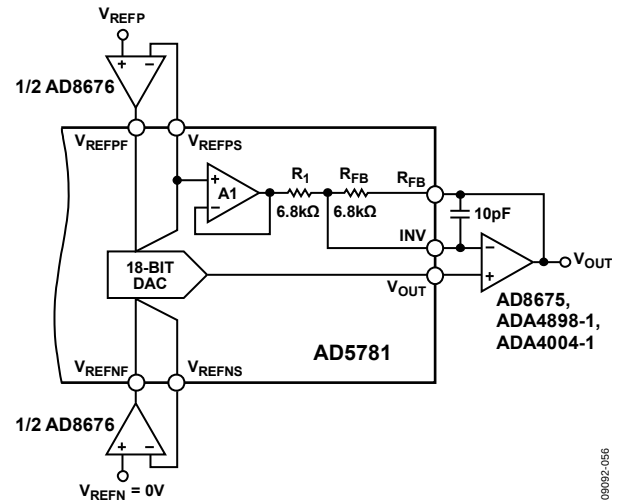


Figure 54. Output Amplifier in Gain of Two Configuration

09002-056

## APPLICATIONS INFORMATION

## TYPICAL OPERATING CIRCUIT

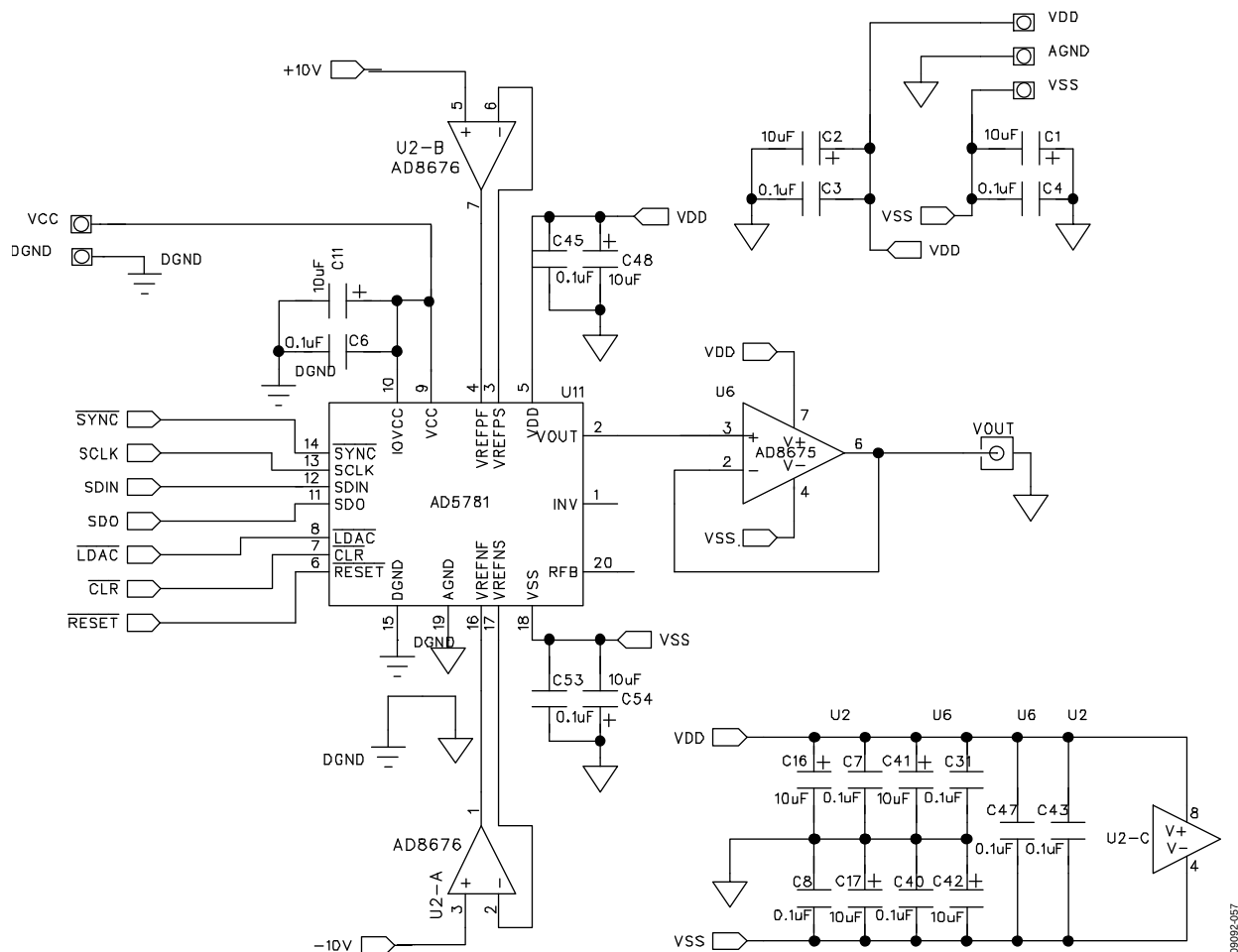


Figure 55. Typical Operating Circuit

Figure 55 shows a typical operating circuit for the [AD5781](#) using an [AD8676](#) for reference buffers and an [AD8675](#) as an output buffer. To meet the specified linearity, force sense buffers must be used on the reference inputs. Because the output impedance of the [AD5781](#) is 3.4 k $\Omega$ , an output buffer is required for driving low resistive, high capacitive loads.

## EVALUATION BOARD

An evaluation board is available for the [AD5781](#) to aid designers in evaluating the high performance of the part with minimum effort. The [AD5781](#) evaluation kit includes a populated and tested [AD5781](#) PCB. The evaluation board interfaces to the USB port of a PC. Software is available with the evaluation board to allow the user to easily program the [AD5781](#). The software runs on any PC that has Microsoft® Windows® XP (SP2) or Vista (32 bits) installed. The [EVAL-AD5781](#) data sheet is available, which gives full details on the operation of the evaluation board

## OUTLINE DIMENSIONS

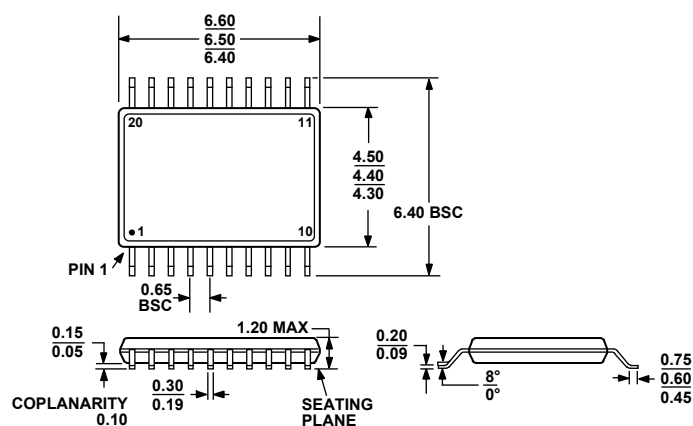


Figure 56. 20-Lead Thin Shrink Small Outline Package [TSSOP]  
(RU-20)

Dimensions shown in millimeters

## ORDERING GUIDE

| Model <sup>1</sup> | Temperature Range | INL      | Package Description | Package Option |
|--------------------|-------------------|----------|---------------------|----------------|
| AD5781BRUZ         | −40°C to +125°C   | ±0.5 LSB | 20-Lead TSSOP       | RU-20          |
| AD5781BRUZ-REEL7   | −40°C to +125°C   | ±0.5 LSB | 20-Lead TSSOP       | RU-20          |
| AD5781ARUZ         | −40°C to +125°C   | ±4 LSB   | 20-Lead TSSOP       | RU-20          |
| AD5781ARUZ-REEL7   | −40°C to +125°C   | ±4 LSB   | 20-Lead TSSOP       | RU-20          |
| EVAL-AD5781SDZ     |                   |          | Evaluation Board    |                |

<sup>1</sup> Z = RoHS Compliant Part.



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